



Partial RF Exposure Report

(Part 2: Test Under Dynamic Transmission Condition)

FCC ID : 2AFZZRKC7G
Equipment : Mobile Phone
Brand Name : POCO
Model Name : 24122RKC7G
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Standard : FCC 47 CFR Part 2 (2.1093)

We, SPORTON INTERNATIONAL INC., would like to declare that the tested sample has been evaluated in accordance with the test procedures and has been in compliance with the applicable technical standards.

The test results in this report apply exclusively to the tested model / sample. Without written approval of SPORTON INTERNATIONAL INC. EMC & Wireless Communications Laboratory, the test report shall not be reproduced except in full.

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History of this test report

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Contents

1 Introduction	5
2 Tx Varying Transmission Test Cases and Test Proposal	6
3 SAR Time Averaging Validation Test Procedures	9
3.1 Test sequence determination for validation	9
3.2 Test configuration selection criteria for validating Smart Transmit feature.....	9
3.2.1 Test configuration selection for time-varying Tx power transmission.....	10
3.2.2 Test configuration selection for change in call	10
3.2.3 Test configuration selection for change in technology/band	10
3.2.4 Test configuration selection for change in DSI	11
3.2.5 Test configuration selection for SAR exposure switching	11
3.2.6 Test configuration selection for change in time window.....	12
3.2.7 Test configuration selection for Exposure Category Switch.....	12
3.2.8 Test configuration selection for system level compliance continuity	14
3.3 Test procedures for conducted power measurements	15
3.3.1 Time-varying Tx power transmission scenario.....	15
3.3.2 Change in call scenario	17
3.3.3 Change in technology and band	18
3.3.4 Change in antenna	19
3.3.5 Change in DSI	19
3.3.6 Change in time window.....	20
3.3.7 SAR exposure switching	22
3.3.8 Test procedure for Exposure Category Switch	23
3.3.9 Test procedure for System level compliance continuity	24
3.4 Test procedure for time-varying SAR measurements	27
4 Test Configurations	29
4.1 WWAN (sub-6) transmission.....	29
5 Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation.....	34
5.1 Measurement setup	34
5.2 P_{limit} and P_{max} measurement results	37
5.3 Time-varying Tx power measurement results	38
5.3.1 LTE Band 5.....	39
5.3.2 LTE Band 42.....	41
5.3.3 5G NR n66.....	43
5.3.4 5G NR n78.....	45
5.4 Change in Call Test Results	47
5.5 Change in technology/band test results	48
5.6 Change in DSI test results	49
5.7 Change in Time window / antenna switch test results.....	50
5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2.....	50
5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42.....	51
5.8 Switch in SAR exposure test results (EN-DC Combination)	52
5.9 Exposure Category Switch Test results	53
6 SAR Test Results for Sub-6 Smart Transmit Feature Validation	55
6.1 Measurement setup	55
6.2 SAR measurement results for time-varying Tx power transmission scenario	56



6.2.1 LTE B5 SAR test results	57
6.2.2 LTE B42 SAR test results	59
6.2.3 5G NR n66 SAR test results	61
6.2.4 5G NR n78 SAR test results	63

7 Conclusions	64
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Appendix A. Test Sequences

Appendix B. Test Procedures for 5GNR + LTE Radio

Appendix C. System Verification

Appendix D. DASY Calibration Certificate

Appendix E. Test Setup Photos

1 Introduction

The equipment under test (EUT) is a Mobile Phone (FCC ID: 2AFZZRKC7G), it contains the Qualcomm modem supporting 2G/3G/4G/5G technologies and WLAN/BT technologies. Both of these modems are enabled with Qualcomm Smart Transmit feature to control and manage transmitting power in real time and to ensure at all times the time-averaged RF exposure is in compliance with the FCC requirement.

This purpose of the Part 2 report is to demonstrate the EUT complies with FCC RF exposure requirement under Tx varying transmission scenarios, thereby validity of Qualcomm Smart Transmit feature for FCC equipment authorization. It serves to compliment the Part 0 and Part 1 Test Reports to justify compliance per FCC.

The P_{limit} used in this report is determined in Part 0 and Part 1 report. Refer to Part 1 SAR report, for product description and terminology used in this report.

Per Qualcomm's document, embedded file system (EFS) version 23 products are required to be verified for Smart Tx generation for relevant MCC settings. It was confirmed that this DUT contains embedded file system (EFS) version 23 configured for Qualcomm® Smart Transmit™ 5.0 of GEN2 phase VI for Sub6, WLAN/BT with MCC settings for the US market.

Remark: In this report only demonstrated WWAN TAS compliance, for the WLAN/BT TAS validation is separate report and refers to FA491407C Part 2 report.

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2 Tx Varying Transmission Test Cases and Test Proposal

To validate time averaging feature and demonstrate the compliance in Tx varying transmission conditions, the following transmission scenarios are covered in Part 2 test:

1. During a time-varying Tx power transmission: To prove that the Smart Transmit feature accounts for Tx power variations in time accurately.
2. During a call disconnect and re-establish scenario: To prove that the Smart Transmit feature accounts for history of past Tx power transmissions accurately.
3. During technology/band handover: To prove that the Smart Transmit feature functions correctly during transitions in technology/band.
4. During DSI (Device State Index) change: To prove that the Smart Transmit feature functions correctly during transition from one device state (DSI) to another.
5. During antenna (or beam) switch: To prove that the Smart Transmit feature functions correctly during transitions in antenna (such as AsDiv scenario) or beams (different antenna array configurations).
6. During change in device state: To prove that the Smart Transmit feature functions correctly during transitions in device state, say, from body-worn state to hotspot mode (i.e., when hotspot mode is turned ON), or say, from extremity mode to body-worn state (grip sensor triggered OFF), etc. Device state here refers to all the device configurations required to be tested by FCC, for example, head position, body-worn position, hotspot mode, and extremity.
7. During time window switch: To prove that the Smart Transmit feature correctly handles the transition from one time window to another specified by FCC, and maintains the normalized time-averaged RF exposure to be less than FCC limit of 1.0 at all times.
8. SAR exposure switching between two active radios (radio1 and radio2): To prove that the Smart Transmit feature functions correctly and ensures total RF exposure compliance when exposure varies among SAR_radio1 only, SAR_radio1 + SAR_radio2, and SAR_radio2 only scenarios.
9. System level compliance continuity:
 - a. Within terrestrial networks (WWAN, WLAN, BT, etc.): To demonstrate the time averaged RF exposure compliance continuity during technology transition in both single-radio and multi-radio transmission scenarios and under both modes (i.e., ON and airplane) of WWAN modem while the USB is disconnected.

As described in Part 0 report, the RF exposure is proportional to the Tx power for a SAR-characterized wireless device. Thus, feature validation in Part 2 can be effectively performed through conducted and radiated power measurement. Therefore, the compliance demonstration under dynamic transmission conditions and feature validation are done in conducted/radiated power measurement setup for transmission scenario 1 through 8.

To add confidence in the feature validation, the time-averaged SAR measurements are also performed but only performed for transmission scenario 1 to avoid the complexity in SAR measurement (such as, for scenario 3 requiring change in SAR probe calibration file to accommodate different bands and/or tissue simulating liquid).

The strategy for testing in Tx varying transmission condition is outlined as follows:

- Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR limits, through time-averaged power measurements
 - Measure conducted Tx power (for $f < 6\text{GHz}$) versus time, and radiated Tx power (EIRP for $f > 10\text{GHz}$) versus time.
 - Convert it into RF exposure and divide by respective FCC limits to get normalized exposure versus time.
 - Perform running time-averaging over FCC defined time windows.
 - Demonstrate that the total normalized time-averaged RF exposure is less than 1 for all transmission scenarios at all times.

Mathematical expression:

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured $1gSAR$ or $10gSAR$ values at P_{limit} corresponding to sub-6 transmission.

- Demonstrate the total RF exposure averaged over FCC defined time windows does not exceed FCC's SAR limits, through time-averaged SAR measurements. Note as mentioned earlier, this measurement is performed for transmission scenario 1 only.
 - For sub-6 transmission only, measure instantaneous SAR versus time; for LTE+ sub6 NR transmission, request low power (or all-down bits) on LTE so that measured SAR predominantly corresponds to sub6 NR.
 - Convert it into RF exposure and divide by respective FCC limits to obtain normalized exposure versus time.
 - Perform time averaging over FCC defined time window.
 - Demonstrate that the total normalized time-averaged RF exposure is less than 1 for transmission scenario 1 at all times.

Mathematical expression:

- For sub-6 transmission only:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_P_{limit}} * 1g_or_10gSAR(t)_{P_{limit}} \quad (3a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (3b)$$

where, $pointSAR(t)$, $pointSAR_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous point SAR, measured point SAR at P_{limit} , and measured 1gSAR or 10gSAR values at P_{limit} corresponding to sub-6 transmission.

NOTE: cDASY6 measurement system by Schmid & Partner Engineering AG (SPEAG) of Zurich, Switzerland measures relative E-field, and provides ratio of $\frac{[pointE(t)]^2}{[pointE_input.power.limit]^2}$ versus time.

3 SAR Time Averaging Validation Test Procedures

This chapter provides the test plan and test procedure for validating Qualcomm Smart Transmit feature for sub-6 transmission. The 100 seconds time window for operating $f < 3\text{GHz}$ is used as an example to detail the test procedures in this chapter.

3.1 Test sequence determination for validation

Following the FCC recommendation, two test sequences having time-variation in Tx power are predefined for sub-6 ($f < 6\text{GHz}$) validation:

- Test sequence 1: request EUT's Tx power to be at maximum power, measured $P_{max}^{\dagger}$, for 80s, then requesting for half of the maximum power, i.e., measured $P_{max}/2$, for the rest of the time.
- Test sequence 2: request EUT's Tx power to vary with time. This sequence is generated relative to measured P_{max} , measured P_{limit} and calculated $P_{reserve}$ (= measured P_{limit} in dBm - Reserve_power_margin in dB) of EUT based on measured P_{limit} .

The details for generating these two test sequences is described and listed in Appendix A.

NOTE: NOTE: For test sequence generation, “measured Plimit” and “measured Pmax” are used instead of the “Plimit” specified in EFS entry and “Pmax” specified for the device, because Smart Transmit feature operates against the actual power level of the “Plimit” that was calibrated for the EUT. The “measured Plimit” accurately reflects what the feature is referencing to, therefore, it should be used during feature validation testing. The RF tune up and device-to-device variation are already considered in Part 0 report prior to determining Plimit.

3.2 Test configuration selection criteria for validating Smart Transmit feature

For validating Smart Transmit feature, this section provides a general guidance to select test cases. In practice, an adjustment can be made in test case selection. The justification/clarification may be provided.

3.2.1 Test configuration selection for time-varying Tx power transmission

The Smart Transmit time averaging feature operation is independent of bands, modes, and channels for a given technology. Hence, validation of Smart Transmit in one band/mode/channel per technology is sufficient.

The criteria for the selection are based on the P_{limit} values determined in Part 1 report. Select the band in each supported technology that corresponds to the P_{limit} value that is less than P_{max} for validating Smart Transmit.

Note this test is designed for single radio transmission scenario. If UE supports sub6 NR in both non-standalone (NSA) and standalone (SA) modes, then validation in time-varying Tx power transmission scenario described in this section needs to be performed in SA mode. Otherwise, it needs to be performed in NSA mode with LTE anchor set to low power. The choice between SA and NSA mode needs to also take into account the selection criteria described below. In general, one mode out of the two modes (NSA or SA) is sufficient for this test.

3.2.2 Test configuration selection for change in call

The criteria to select a test configuration for call-drop measurement is:

- Select technology/band with least P_{limit} among all supported technologies/bands, and select the radio configuration (e.g., # of RBs, channel#) in this technology/band that corresponds to the highest *measured* 1gSAR at P_{limit} listed in Part 1 report.
- In case of multiple bands having same least P_{limit} , then select the band having the highest *measured* 1gSAR at P_{limit} in Part 1 report.

This test is performed with the EUT's Tx power requested to be at maximum power, the above band selection will result in Tx power enforcement (i.e., EUT forced to have Tx power at $P_{reserve}$) for longest duration in one FCC defined time window. The call change (call drop/reestablish) is performed during the Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$). One test is sufficient as the feature operation is independent of technology and band.

3.2.3 Test configuration selection for change in technology/band

The selection criteria for this measurement is, for a given antenna, to have EUT switch from a technology/band with lowest P_{limit} within the technology group (in case of multiple bands having the same P_{limit} , then select the band with highest *measured* 1gSAR at P_{limit}) to a technology/band with highest P_{limit} within the technology group, in case of multiple bands having the same P_{limit} , then select the band with lowest *measured* 1gSAR at P_{limit} in Part 1 report, or vice versa.

This test is performed with the EUT's Tx power requested to be at maximum power, the technology/band switch is performed during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.4 Test configuration selection for change in DSI

The criteria to select a test configuration for DSI change test is

- Select a technology/band having the $P_{limit} < P_{max}$ within any technology and DSI group, and for the same technology/band having a different P_{limit} in any other DSI group. Note that the selected DSI transition need to be supported by the device.

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band, and DSI change is conducted during Tx power enforcement duration (i.e., during the time when EUT is forced to have Tx power at $P_{reserve}$).

3.2.5 Test configuration selection for SAR exposure switching

If supported, the test configuration for SAR exposure switching should cover

1. SAR exposure switch when two active radios are in the same time window
2. SAR exposure switch when two active radios are in different time windows. One test with two active radios in any two different time windows is sufficient as Smart Transmit operation is the same for RF exposure switch in any combination of two different time windows.

The Smart Transmit time averaging operation is independent of the source of SAR exposure (for example, LTE vs. Sub6 NR) and ensures total time-averaged RF exposure compliance. Hence, validation of Smart Transmit in any one simultaneous SAR transmission scenario (i.e., one combination for LTE + Sub6 NR transmission) is sufficient, where the SAR exposure varies among SAR_{radio1} only, $SAR_{radio1} + SAR_{radio2}$, and SAR_{radio2} only scenarios.

The criteria to select a test configuration for validating Smart Transmit feature during SAR exposure switching scenarios is

- Select any two < 6GHz technologies/bands that the EUT supports simultaneous transmission (for example, LTE+ Sub6 NR).
- Among all supported simultaneous transmission configurations, the selection order is
 1. select one configuration where both P_{limit} of radio1 and radio2 is less than their corresponding P_{max} , preferably, with different P_{limits} . If this configuration is not available, then,
 2. select one configuration that has P_{limit} less than its P_{max} for at least one radio. If this can not be found, then,
 3. select one configuration that has P_{limit} of radio1 and radio2 greater than P_{max} but with least $(P_{limit} - P_{max})$ delta.

SAR exposure switch validation with one simultaneous transmission scenario (i.e., either FR1 NSA or LTE inter-band ULCA) is sufficient as Smart Transmit operation is the same.

3.2.6 Test configuration selection for change in time window

FCC specifies different time window for time averaging based on operation frequency. The criteria to select a test configuration for validating Smart Transmit feature and demonstrating the compliance during the change in time window is

- Select any technology/band that has operation frequency classified in one time window defined by FCC (such as 100-seconds time window), and its corresponding P_{limit} is less than P_{max} if possible.
- Select the 2nd technology/band that has operation frequency classified in a different time window defined by FCC (such as 60-seconds time window), and its corresponding P_{limit} is less than P_{max} if possible.
- It is preferred both P_{limit} values of two selected technology/band less than corresponding P_{max} , but if not possible, at least one of technologies/bands has its P_{limit} less than P_{max} .

This test is performed with the EUT's Tx power requested to be at maximum power in selected technology/band. Test for one pair of time windows selected is sufficient as the feature operation is the same.

3.2.7 Test configuration selection for Exposure Category Switch

When exposure DSI changes from head to body-worn or vice versa, it is obvious that the exposure from an active radio does not expose the same tissues. Therefore, with Qualcomm Smart Transmit EFS version 18 (or higher), the exposure continuity is handled in two categories: Head exposure and non-head exposure.

- Head exposure category includes all 4 positions of left cheek, left tilted, right cheek and right titled
- Non-head exposure category includes all other exposure scenarios (except head), i.e., body-worn, hotspot, extremity, etc.

The purpose of this test is to demonstrate that Smart Transmit ensures time-averaged RF exposure compliance when the EUT exposure category changes. For this purpose, there are two tests performed: (a) start with head exposure and switch to non-head exposure and switch back to head exposure, and (b) start with non-head exposure and switch to head exposure and switch back to non-head exposure.

The criteria to select a test configuration for exposure category switch measurement is:

□ If $P_{limit} < P_{max}$ for at least one radio out of all supported technology/band/antenna /DSI, then:

(a) Out of all head exposure DSIs, select a technology/band/antenna/DSI having the least P_{limit} ($< P_{max}$), furthermore, having the largest difference between P_{max} and P_{limit} ($P_{limit} < P_{max}$) should be considered in the selection. Then, select a second DSI in the nonhead exposure category DSI that has the least P_{limit} among all the non-head DSIs for the same technology/band/antenna. This technology/band /antenna and selected DSIs are used for head to non-head to head exposure switch test. If the $P_{limit} > P_{max}$ for

all supported technology/band/antenna/DSI in head exposure category, then this test is not required.

(b) Similarly, out of all non-head exposure DSIs, select a technology/band/antenna/DSI having the least $P_{limit} (< P_{max})$, furthermore, having the largest difference between P_{max} and $P_{limit} (P_{limit} < P_{max})$ should be considered in the selection. Then, select a second DSI in the head exposure category DSI that has the least P_{limit} among all the head DSIs for the same technology/band/antenna. This technology/band/antenna and selected DSIs are used for non-head to head to non-head exposure switch test. If the $P_{limit} > P_{max}$ for all supported technology/band/antenna/DSI in non-head exposure category, then this test is not required.

□ If $P_{limit} > P_{max}$ for all supported technology/band/antenna/DSIs for both head and nonhead DSI categories, then:

(c) select a supported sub6 simultaneous transmission scenario (like LTE + FR1 NSA, or LTE inter-band ULCA, or FR1 inter-band NR-DC, etc.) in head DSI that has $P_{limit} < P_{max} + 10 \cdot \log(N)$ for all radios of selected technology(s)/band(s)/antenna(s), where N is the number of active radios in selected sub6 simultaneous transmission scenario. Note that the antennas determined for the selected radios of simultaneous transmission scenario should be in the same antenna group if EUT is configured with GEN2_SUB6. Then, select a second DSI in the non-head exposure category that has the lowest P_{limit} among all the non-head DSIs for all the radios of the selected

technology(s)/band(s)/antenna(s) simultaneous transmission scenario. This selected technology(s)/band(s)/antenna(s) and selected DSIs are used for head to non-head to head exposure switch test. If the head DSI has $P_{limit} > P_{max} + 10 \cdot \log(N)$ for all radios supported in sub6 simultaneous transmission scenarios, then this test is not required.

(d) select a supported sub6 simultaneous transmission scenario (like LTE + FR1 NSA, or LTE inter-band ULCA, or FR1 inter-band NR-DC, etc.) in non-head DSI that has $P_{limit} < P_{max} + 10 \cdot \log(N)$ for all radios of the selected technology(s)/band(s)/antenna(s), where N is the number of active radios in selected sub6 simultaneous transmission scenario. Note that the antennas determined for the selected radios of simultaneous transmission scenario should be in the same antenna group if EUT is configured with GEN2_SUB6. Then, select a second DSI in the head exposure category that has the lowest P_{limit} among all the head DSIs for all the radios of the selected technology(s)/band(s)/antenna(s) simultaneous transmission scenario. This selected technology(s)/band(s)/antenna(s) and selected DSIs are used for non-head to head to non-head exposure switch test. If the non-head DSI has $P_{limit} > P_{max} + 10 \cdot \log(N)$ for all radios supported in sub6 simultaneous transmission scenarios, then this test is not required.

□ Use the highest measured 1g_or_10g SAR at $P_{limit} (P_{limit} < P_{max})$ shown in Part 1 report for the selected tech/band/antenna/DSI out of all radio configurations and device positions in Equation (1a) and (3a) to calculate time-varying SAR. However, in the case of $P_{limit} > P_{max}$, the SAR measured in Part 1 report for the corresponding radio configuration selected and tested in Part 2 should be applied in Equation (1a) and (3a).

3.2.8 Test configuration selection for system level compliance continuity

3.2.8.1 Selection criteria for WWAN, WLAN, BT system level test

The purpose of system level compliance test is to demonstrate the time-averaged RF exposure compliance continuity in the following scenarios while the USB is disconnected:

1. Across technology switch
2. During transition from single technology to multi-technology
3. In transition when WWAN went from ON to airplane mode
4. Active WLAN radio and/or Bluetooth (BT) radio with WWAN in airplane mode
5. Time window transition when WWAN in airplane mode
6. In transition when WWAN went from airplane mode to ON.

Note: Technology in this section refers to WWAN, WLAN or BT

The selection criteria for radios to be tested is to select a radio which has the largest P_{max}/P_{limit} ratio among all configurations supported (including SISO, MIMO, DBS, SISO+MIMO or DBS+MIMO whichever appropriate) within each technology and within the same antenna group.

3.3 Test procedures for conducted power measurements

This section provides general conducted power measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

3.3.1 Time-varying Tx power transmission scenario

This test is performed with the two pre-defined test sequences described in Section 3.1 for all the technologies and bands selected in Section 3.2.1. The purpose of the test is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged SAR (corresponding time-averaged Tx power) does not exceed the FCC limit at all times (see Eq. (1a) and (1b)).

Test procedure

1. Measure P_{max} , measure P_{limit} and calculate $P_{reserve}$ (= measured P_{limit} in dBm – Reserve power margin in dB) and follow Section 3.1 to generate the test sequences for all the technologies and bands selected in Section 3.2.1. Both test sequence 1 and test sequence 2 are created based on measured P_{max} and measured P_{limit} of the EUT. Test condition to measure P_{max} and P_{limit} is:
 - Measure P_{max} with Smart Transmit disabled and callbox set to request maximum power.
 - Measure P_{limit} with Smart Transmit Peak exposure mode enabled, callbox set to request maximum power.
 - Measure $P_{reserve}$ via test sequence 1 measurement.
2. Set the EUT to the intended Smart Transmit exposure mode, and then set callbox requesting the EUT's Tx power to be at pre-defined test sequence 1, measure and record Tx power versus time, and then convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (1a)) using measured P_{limit} from above Step 1. Perform running time average to determine time-averaged power and 1gSAR or 10gSAR versus time as illustrated in Figure 3-1 where using 100-seconds time window as an example.

NOTE: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

NOTE: For an easier computation of the running time average, 0 dBm can be added at the beginning of the test sequences the length of the responding time window, for example, add 0dBm for 100-seconds so the running time average can be directly performed starting with the first 100-seconds data using excel spreadsheet. This technique applies to all tests performed in this Part 2 report for easier time-averaged computation using excel spreadsheet.

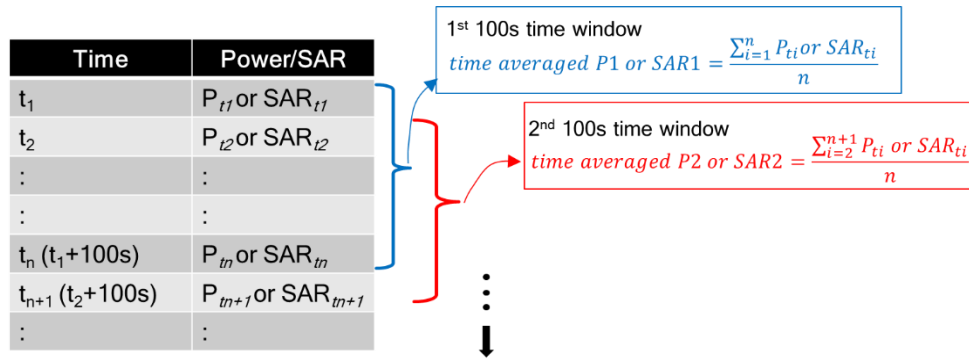


Figure 3-1 100s running average illustration

3. Make one plot containing:
 - a. Instantaneous Tx power versus time measured in Step 2,
 - b. Requested Tx power used in Step 2 (test sequence 1),
 - c. Computed time-averaged power versus time determined in Step 2,
 - d. Time-averaged power limit (corresponding to FCC SAR limit of 1.6 W/kg for 1gSAR or 4.0W/kg for 10gSAR) given by

$$Time\ averaged\ power\ limit = meas.P_{limit} + 10 \times \log\left(\frac{FCC\ SAR\ limit}{meas.SAR_Plimit}\right) \quad (5a)$$

where $meas.P_{limit}$ and $meas.SAR_Plimit$ correspond to measured power at P_{limit} and measured SAR at P_{limit} .

4. Make another plot containing:
 - a. Computed time-averaged 1gSAR or 10gSAR versus time determined in Step 2
 - b. FCC $1gSAR_{limit}$ of 1.6W/kg or FCC $10gSAR_{limit}$ of 4.0W/kg.
5. Repeat Steps 2 ~ 4 for pre-defined test sequence 2 and replace the requested Tx power (test sequence 1) in Step 2 with test sequence 2.
6. Repeat Steps 2 ~ 5 for all the selected technologies and bands.

The validation criteria are, at all times, the time-averaged power versus time shown in Step 3 plot shall not exceed the time-averaged power limit (defined in Eq. (5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shown in Step 4 plot shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

3.3.2 Change in call scenario

This test is to demonstrate that Smart Transmit feature accurately accounts for the past Tx powers during time-averaging when a new call is established.

The call disconnects and re-establishment needs to be performed during power limit enforcement, i.e., when the EUT's Tx power is at $P_{reserve}$ level, to demonstrate the continuity of RF exposure management and limiting in call change scenario. In other words, the RF exposure averaged over any FCC defined time window (including the time windows containing the call change) doesn't exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

Test procedure

7. Measure P_{limit} for the technology/band selected in Section 3.2.2. Measure P_{limit} with Smart Transmit Peak exposure mode enabled, callbox set to request maximum power.
8. Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit.
9. Establish radio link with callbox in the selected technology/band.
10. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then drop the call for ~10 seconds. Afterwards, re-establish another call in the same radio configuration (i.e., same technology/band/channel) and continue callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time. Once the measurement is done, extract instantaneous Tx power versus time, convert the measured conducted Tx power into 1gSAR or 10gSAR value using Eq. (1a), and then perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.

NOTE: In Eq.(1a), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

11. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
12. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged power versus time shall not exceed the time-averaged power limit (defined in Eq.(5a)), in turn, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (1b)).

3.3.3 Change in technology and band

This test is to demonstrate the correct power control by Smart Transmit during technology switches and/or band handovers.

Similar to the change in call test in Section 3.3.2, to validate the continuity of RF exposure limiting during the transition, the technology and band handover needs to be performed when EUT's Tx power is at $P_{reserve}$ level (i.e., during Tx power enforcement) to make sure that the EUT's Tx power from previous $P_{reserve}$ level to the new $P_{reserve}$ level (corresponding to new technology/band). Since the P_{limit} could vary with technology and band, Eq. (1a) can be written as follows to convert the instantaneous Tx power in 1gSAR or 10gSAR exposure for the two given radios, respectively:

$$1g_or_10gSAR_1(t) = \frac{conducted_Tx_power_1(t)}{conducted_Tx_power_P_{limit_1}} * 1g_or_10gSAR_P_{limit_1} \quad (6a)$$

$$1g_or_10gSAR_2(t) = \frac{conducted_Tx_power_2(t)}{conducted_Tx_power_P_{limit_2}} * 1g_or_10gSAR_P_{limit_2} \quad (6b)$$

$$\frac{1}{T_{SAR}} \left[\int_{t-T_{SAR}}^{t_1} \frac{1g_or_10gSAR_1(t)}{FCC\ SAR\ limit} dt + \int_{t-T_{SAR}}^t \frac{1g_or_10gSAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1 \quad (6c)$$

where, $conducted_Tx_power_1(t)$, $conducted_Tx_power_P_{limit_1}$, and $1g_or_10gSAR_P_{limit_1}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR or 10gSAR value at P_{limit} of technology1/band1; $conducted_Tx_power_2(t)$, $conducted_Tx_power_P_{limit_2}(t)$, and $1g_or_10gSAR_P_{limit_2}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR or 10gSAR value at P_{limit} of technology2/band2. Transition from technology1/band1 to the technology2/band2 happens at time-instant ' t_1 '.

Test procedure

13. Measure P_{limit} for both the technologies and bands selected in Section 3.2.3.
Measure P_{limit} with Smart Transmit Peak exposure mode enabled, callbox set to request maximum power.
14. Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit
15. Establish radio link with callbox in first technology/band selected.
16. Request EUT's Tx power at 0 dBm for at least one time window specified for the selected technology/band, followed by requesting EUT's Tx power to be at maximum power for about ~60 seconds, and then switch to second technology/band selected. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time of at least another full duration of the specified time window. Measure and record Tx power versus time for the full duration of the test.
17. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value using Eq. (6a) and (6b) and corresponding measured P_{limit} values from Step 1 of this section. Perform the running time average to determine time-averaged power and 1gSAR or 10gSAR versus time.

NOTE: **NOTE:** In Eq.(6a) & (6b), instantaneous Tx power is converted into instantaneous 1gSAR or 10gSAR value by applying the measured worst-case 1gSAR or 10gSAR value at P_{limit} for the corresponding technology/band/antenna/DSI reported in Part 1 report.

18. Make one plot containing: (a) instantaneous Tx power versus time, (b) requested power, (c) computed time-averaged power, (d) time-averaged power limit calculated using Eq.(5a).
19. Make another plot containing: (a) computed time-averaged 1gSAR or 10gSAR versus time, and (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (6c)).

3.3.4 Change in antenna

This test is to demonstrate the correct power control by Smart Transmit during antenna switches from one antenna to another. The test procedure is identical to Section 3.3.3, by replacing technology/band switch operation with antenna switch. The validation criteria are, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

NOTE: **NOTE:** If the EUT does not support antenna switch within the same technology/band, but has multiple antennas to support different frequency bands, then the antenna switch test is included as part of change in technology and band (Section 3.3.3) test.

3.3.5 Change in DSI

This test is to demonstrate the correct power control by Smart Transmit during DSI switches from one DSI to another. The test procedure is identical to Section 3.3.3, by replacing technology/band switch operation with DSI switch. The validation criteria are, at all times, the time-averaged normalized exposure versus time shall not exceed the normalized limit of 1.0.

3.3.6 Change in time window

This test is to demonstrate the correct power control by Smart Transmit during the change in averaging time window when a specific band handover occurs. FCC specifies time-averaging windows of 100s for Tx frequency < 3GHz, and 60s for Tx frequency between 3GHz and 6GHz.

To validate the continuity of RF exposure limiting during the transition, the band handover test needs to be performed when EUT handovers from operation band less than 3GHz to greater than 3GHz and vice versa. The equations (3a) and (3b) in Section 2 can be written as follows for transmission scenario having change in time window,

$$1gSAR_1(t) = \frac{\text{conducted_Tx_power_1}(t)}{\text{conducted_Tx_power_P}_{limit_1}} * 1g_or\ 10g_SAR_P_{limit_1} \quad (7a)$$

$$1gSAR_2(t) = \frac{\text{conducted_Tx_power_2}(t)}{\text{conducted_Tx_power_P}_{limit_2}} * 1g_or\ 10g_SAR_P_{limit_2} \quad (7b)$$

$$\frac{1}{T_{1SAR}} \left[\int_{t-T_{1SAR}}^{t_1} \frac{1g_or\ 10g_SAR_1(t)}{FCC\ SAR\ limit} dt \right] + \frac{1}{T_{2SAR}} \left[\int_{t-T_{2SAR}}^t \frac{1g_or\ 10g_SAR_2(t)}{FCC\ SAR\ limit} dt \right] \leq 1 \quad (7c)$$

where, *conducted_Tx_power_1(t)*, *conducted_Tx_power_P_{limit_1}(t)*, and *1g_or 10g_SAR_P_{limit_1}* correspond to the instantaneous Tx power, conducted Tx power at *P_{limit_1}*, and compliance *1g_or 10g_SAR* values at *P_{limit_1}* of band1 with time-averaging window '*T_{1SAR}*'; *conducted_Tx_power_2(t)*, *conducted_Tx_power_P_{limit_2}(t)*, and *1g_or 10g_SAR_P_{limit_2}* correspond to the instantaneous Tx power, conducted Tx power at *P_{limit_2}*, and compliance *1g_or 10g_SAR* values at *P_{limit_2}* of band2 with time-averaging window '*T_{2SAR}*'. One of the two bands is less than 3GHz, another is greater than 3GHz. Transition from first band with time-averaging window '*T_{1SAR}*' to the second band with time-averaging window '*T_{2SAR}*' happens at time-instant '*t₁*'.

Test procedure

20. Measure *P_{limit}* for both the technologies and bands selected in Section 3.2.6.
Measure *P_{limit}* with Smart Transmit Peak exposure mode enabled, callbox set to request maximum power.
21. Set *Reserve_power_margin* to actual (intended) value and enable Smart Transmit

Transition from 100s time window to 60s time window, and vice versa

22. Establish radio link with callbox in the technology/band having 100s time window selected in Section 3.2.6.
23. Request EUT's Tx power to be at 0 dBm for at least 100 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~140 seconds, and then switch to second technology/band (having 60s time window) selected in Section 3.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~60s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for at least another 100s. Measure and record Tx power versus time for the entire duration of the test.
24. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1gSAR or 10gSAR value (see Eq. (7a) and (7b)) using corresponding technology/band Step 1 result, and then perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time. Note that in Eq.(7a) & (7b), instantaneous Tx power is converted into instantaneous

- 1gSAR or 10gSAR value by applying the worst-case 1gSAR or 10gSAR value tested in Part 1 for the selected technologies/bands at P_{limit} .
25. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 4.
26. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 5, (b) computed time-averaged 1gSAR versus time determined in Step 5, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

Transition from 60s time window to 100s time window, and vice versa

27. Establish radio link with callbox in the technology/band having 60s time window selected in Section 3.2.6.
28. Request EUT's Tx power to be at 0 dBm for at least 60 seconds, followed by requesting EUT's Tx power to be at maximum power for about ~80 seconds, and then switch to second technology/band (having 100s time window) selected in Section 3.2.6. Continue with callbox requesting EUT's Tx power to be at maximum power for about ~100s in this second technology/band, and then switch back to the first technology/band. Continue with callbox requesting EUT's Tx power to be at maximum power for the remaining time for a total test time of 500 seconds. Measure and record Tx power versus time for the entire duration of the test.
29. Repeat above Step 5~7 to generate the plots
- The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg

3.3.7 SAR exposure switching

This test is to demonstrate that Smart Transmit feature is accurately accounts for switching in exposures among SAR from radio1 only, SAR from both radio1 and radio2, and SAR from radio2 only scenarios, and ensures total time-averaged RF exposure complies with the FCC limit. Here, radio1 represents primary radio (for example, LTE anchor in a NR non-standalone mode call) and radio2 represents secondary radio (for example, sub6 NR). The detailed test procedure for SAR exposure switching in the case of LTE+ sub6 NR non-standalone mode transmission scenario is provided in Appendix B.2.

Test procedure:

30. Measure conducted Tx power corresponding to P_{limit} for radio1 and radio2 in selected band. Test condition to measure conducted P_{limit} is:

- Establish device in call with the callbox for radio1 technology/band. Measure conducted Tx power corresponding to radio1 P_{limit} with Smart Transmit Peak exposure mode enabled, callbox set to request maximum power.
- Repeat above step to measure conducted Tx power corresponding to radio2 P_{limit} . If radio2 is dependent on radio1 (for example, non-standalone mode of sub6 NR requiring radio1 LTE as anchor), then establish radio1 + radio2 call with callbox, and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from radio2 sub6 NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)

31. Set EUT to intended Smart Transmit exposure mode, with EUT setup for radio1 + radio2 call. In this description, it is assumed that radio2 has lower priority than radio1. Establish device in radio1+radio2 call, and request all-down bits or low power on radio1, with callbox requesting EUT's Tx power to be at maximum power in radio2 for at least one time window. After one time window, set callbox to request EUT's Tx power to be at maximum power on radio1, i.e., all-up bits. Continue radio1+radio2 call with both radios at maximum power for at least one time window, and drop (or request all-down bits on) radio2. Continue radio1 at maximum power for at least one time window. Record the conducted Tx power for both radio1 and radio2 for the entire duration of this test.

32. Once the measurement is done, extract instantaneous Tx power versus time for both radio1 and radio2 links. Convert the conducted Tx power for both these radios into 1gSAR or 10gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform the running time average to determine time-averaged 1gSAR or 10gSAR versus time.

33. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.

34. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg or $10gSAR_{limit}$ of 4.0W/kg.

3.3.8 Test procedure for Exposure Category Switch

This test is performed with the EUT being requested to transmit at maximum power in selected technology/band/antenna/DSI. The change in exposure category is preferably performed during Tx power enforcement (i.e., EUT forced to transmit at a sustainable level). One test is sufficient as this feature operation is independent of technology, band and antenna. Test procedure are:

In case of head to non-head to head exposure switch test, 'first DSI' in below test procedure refers to head DSI and 'second DSI' refers to non-head DSI. Similarly, in case of non-head to head to non-head exposure switch test, 'first DSI' in below test procedure refers to non-head DSI and 'second DSI' refers to head DSI.

1. Measure *Plimit* for all the technology(s)/band(s)/antenna(s)/DSI(s) selected following the above selection criteria. Measure *Plimit* with Smart Transmit Peak exposure mode enabled and callbox set to request maximum power.
2. Set EUT to intended Smart Transmit exposure mode.
3. Establish radio link with first DSI and with callbox in the selected technology(s)/band(s)/antenna(s).
4. Request EUT to transmit at 0 dBm for at least 100 seconds, followed by requesting EUT to transmit at maximum Tx power for the active radio(s) for half of the regulatory time window, and then switch to the second DSI for ~10s, and switch back to the first DSI for at least one time window. Throughout this test, when switching between DSIs (i.e., switching between exposure categories), continue with callbox requesting EUT to transmit at maximum Tx power for the active radio(s). Measure and record Tx power versus time for the entire duration of the test.
5. Once the measurement is done, extract instantaneous Tx power versus time, and convert the conducted Tx power into 1g_or_10gSAR value (see Eq. (7a) and (7b)) using the corresponding *Plimit* measured in Step 1 and 1g_or_10gSAR value measured in Part 1 report, and then perform 100s running average to determine time-averaged 1g_or_10gSAR versus time as illustrated in Figure 3-1. Note that in Eq.(7a) & (7b), instantaneous Tx power is converted into instantaneous 1g_or_10gSAR value by applying the worst-case 1gSAR value for the selected technologies/bands at *Plimit* as reported in Part 1 report.
6. Make one plot containing: (a) computed time-averaged normalized 1g_or_10gSAR of the selected technology(s)/band(s)/antenna(s) versus time determined in Step 5 for exposure under first DSI, (b) total time-averaged normalized exposure for exposure under first DSI if simultaneous transmission scenario was tested, and (c) normalized regulatory limit of 1.0.
7. Make another plot containing: (a) computed time-averaged 1g_or_10gSAR of the selected technology(s)/band(s)/antenna(s) versus time determined in Step 5 for exposure under second DSI, (b) total time-averaged normalized exposure for exposure under second DSI if simultaneous transmission scenario was tested, and (c) normalized regulatory limit of 1.0.

The validation criteria is, at all times, the time-averaged normalized exposure versus time shall not exceed the normalized limit of 1.0 for both first & second DSIs (i.e., both head exposure category and non-head exposure category).

3.3.9 Test procedure for System level compliance continuity

3.3.9.1 WWAN/WLAN/BT radio System level compliance continuity

Below is the test flow outline of the system level compliance test. The test contains 6 sections and 5 transitions: Start with WWAN radio transmission (Section A), transition to WLAN transmission (Section B), transition to simultaneous transmission of WWAN + WLAN + BT (Section C), then drop off WWAN radio and set WWAN to airplane mode, at the same time transition to WLAN+BT transmission simultaneously (Section D), transition to BT only transmission (Section E), and finally transition to WLAN only transmission (Section F) and finally transition back to simultaneous transmission of WWAN + WLAN + BT with modem online while the USB is disconnected.

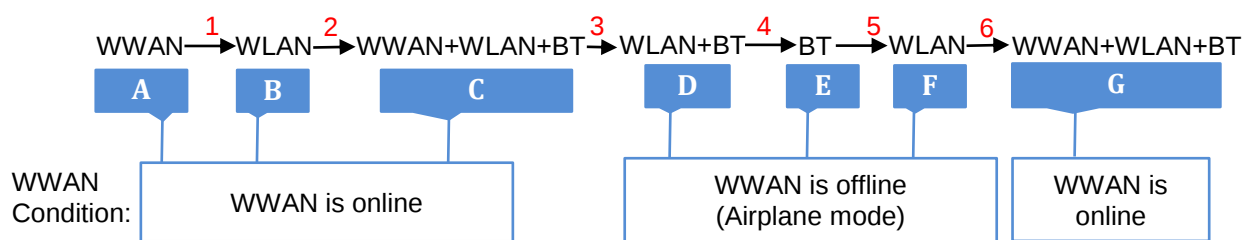


Figure 3-2 Schematic of technology transitions for system level compliance continuity test

It is recommended for OEMs to demonstrate compliance at system level, i.e., demonstrate compliance continuity across technologies, i.e., across WWAN, WLAN, BT, etc. In this regard, a new test case is designed to test the time-averaged RF exposure compliance continuity in the following scenarios with 6 transitions while the USB is disconnected:

1. Across technology switch
2. During transition from single technology to multiple technology
3. In transition when WWAN went from ON to airplane mode
4. Active WLAN radio and/or BT radio without WWAN
5. Time window transition between WLAN and BT when WWAN is in airplane mode (this segment of test is not needed for ICNIRP as both WLAN and BT operate in same time averaging window)
6. In transition when WWAN went from airplane mode to ON.

Test configuration selection criteria:

If the device supports simultaneous transmission of WWAN, WLAN and BT, then the selection criteria for system level compliance continuity test is:

- For a given DSI and antenna group, select band/antenna configurations for WWAN, WLAN and BT technologies that have the largest ($P_{max} - P_{limit}$) delta. In case of multiple bands/antennas having the same difference between P_{max} and P_{limit} within a given technology, then select any one band/antenna out of them.

NOTE:

1. The antennas corresponding to the selected technologies/bands for the system level compliance continuity test case should be in the same antenna group.
2. For this test, WLAN radio configuration is selected different from 2.4GHz band so as to not interfere with BT measurements. Therefore, select least P_{limit} configuration for WLAN outside the 2.4GHz band.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for all three (WWAN, WLAN & BT) technologies in the selected radio configurations. Test condition to measure conducted P_{limit} for each technology is:
 - Establish device in call with the callbox for the first technology in desired band. Measure conducted Tx power corresponding to the first technology P_{limit} with Smart Transmit Peak exposure mode enabled and callbox set to request maximum power (or maximum duty cycle in case of WLAN/BT).
 - Repeat above step to measure conducted Tx power corresponding to the remaining two technologies' P_{limit} . In the case of BT, measured conducted Tx power is compensated by tested duty cycle and BT_STANDALONE EFS parameter, i.e., measured $P_{limit} =$ conducted power measured in BT standalone condition / BT_STANDALONE / BT_duty_cycle.
2. Set EUT to the intended Smart Transmit exposure mode.
3. As depicted in Figure S-1, first
 - i. Section A: Establish WWAN connection with the callbox in selected WWAN radio configuration. Request EUT to transmit at 0 dBm for at least one WWAN time window (100s or 60s), followed by requesting EUT to transmit at maximum Tx power for {one WWAN time window ($T_{WWAN} = 100s$ if $f < 3GHz$ or $60s$ if $3GHz < f < 6GHz$ for FCC, 360s for ICNIRP) + the maximum high power duration allowed in one T_{WWAN} }, denoted as T_{A_WWAN} .
 - ii. Section B: After T_{A_WWAN} , drop WWAN connection and establish WLAN connection with the callbox in selected WLAN radio configuration and request EUT to transmit at maximum duty cycle (and maximum power) for {one WLAN time-window duration ($T_{WLAN} = 30s$ for all WLAN frequency bands for FCC, 360s for ICNIRP) + the maximum high power duration allowed in one T_{WLAN} }, denoted T_{B_WLAN} .
 - iii. Section C: After T_{B_WLAN} , add the selected WWAN and BT radios to have the simultaneous transmission of WWAN + WLAN + BT. Request WWAN radio to transmit at maximum power and request WLAN & BT radios to transmit at maximum duty cycle (and maximum power) for at least one $\max \{T_{A_WWAN}, T_{B_WLAN}, T_{BT}\}$, where, $T_{BT} = 100s$ for FCC, 360s for ICNIRP.
 - iv. Section D: Drop WWAN connection and set WWAN modem into airplane mode. Continue requesting WLAN & BT radios to transmit at maximum duty cycle (and maximum power) for at least two times the $\max \{T_{WLAN}, T_{BT}\}$.
 - v. Section E: Drop WLAN connection. Continue requesting BT radio to transmit at maximum duty cycle (and maximum power). Continue the test for at least one T_{BT} .

- vi. Section F: In the case of FCC time windows, after at least one T_{BT} , drop BT connection and establish back WLAN connection in selected radio configuration. Continue requesting WLAN radio to transmit at maximum duty cycle (and maximum power). Continue the test for at least one $\max\{T_{WLAN}, T_{BT}\}$. In the case of ICNIRP time windows, Section F is not required.
4. Once the measurement is done, extract instantaneous Tx power versus time for all WWAN, WLAN and BT radios in selected configurations. Similar to technology/band switch test in Section 5.3.3, convert the conducted Tx power for both these radios into $1g_or_10gSAR$ value (see Eq. (7a) and (7b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform running average over corresponding time-windows (i.e., 100s/60s for WWAN radio, 30s for WLAN radio and 100s for BT radio in case of FCC time-windows, and 360s for all of them in case of ICNIRP time-windows) to determine time-averaged $1g_or_10gSAR$ versus time as illustrated in Figure 3-1.
5. Make one plot containing: (a) computed normalized time-averaged $1g_or_10gSAR$ for WWAN radio configuration versus time determined in Step 4, (b) computed normalized time-averaged $1g_or_10gSAR$ for WLAN radio configuration versus time determined in Step 4, (c) computed normalized time-averaged $1g_or_10gSAR$ for WLAN radio configuration versus time determined in Step 4, (d) computed total normalized time-averaged $1g_or_10gSAR$ versus time (sum of Steps (5.a), (5.b) and (5.c)) determined in Step 4, and (e) corresponding normalized regulatory $1g_or_10gSAR_{limit}$ limit of 1.0.

The validation criteria is, at all times, the time-averaged $1g_or_10gSAR$ versus time shall not exceed the regulatory $1g_or_10gSAR_{limit}$ limit.

3.4 Test procedure for time-varying SAR measurements

This section provides general time-varying SAR measurement procedures to perform compliance test under dynamic transmission scenarios described in Section 2. In practice, an adjustment can be made in these procedures. The justification/clarification may be provided.

To perform the validation through SAR measurement for transmission scenario 1 described in Section 2, the “path loss” between callbox antenna and EUT needs to be calibrated to ensure that the EUT Tx power reacts to the requested power from callbox in a radiated call. It should be noted that when signaling in closed loop mode, protocol-level power control is in play, resulting in EUT not solely following callbox TPC (Tx power control) commands. In other words, EUT response has many dependencies (RSSI, quality of signal, path loss variation, fading, etc.) other than just TPC commands. These dependencies have less impact in conducted setup (as it is a controlled environment and the path loss can be very well calibrated) but have significant impact on radiated testing in an uncontrolled environment, such as SAR test setup. Therefore, the deviation in EUT Tx power from callbox requested power is expected, however the time-averaged SAR should not exceed FCC SAR requirement at all times as Smart Transmit controls Tx power at EUT.

The following steps are for time averaging feature validation through SAR measurement:

35. “Path Loss” calibration: Place the EUT against the phantom in the worst-case position determined based on Section 3.2.1. For each band selected, prior to SAR measurement, perform “path loss” calibration between callbox antenna and EUT. Since the SAR test environment is not controlled and well calibrated for OTA (Over the Air) test, extreme care needs to be taken to avoid the influence from reflections. The test setup is described in Section 6.1.
36. Time averaging feature validation:
 - i For a given radio configuration (technology/band) selected in Section 3.2.1, enable Smart Transmit Peak exposure mode, with callbox to request maximum power, perform area scan, conduct pointSAR measurement at peak location of the area scan. This point SAR value, $pointSAR_{P_{limit}}$, corresponds to point SAR at the measured P_{limit} (i.e., measured P_{limit} from the EUT in Step 1 of Section 3.3.1).
 - ii Set *Reserve_power_margin* to actual (intended) value and reset power on EUT to enable Smart Transmit. Note, if *Reserve_power_margin* cannot be set wirelessly, care must be taken to re-position the EUT in the exact same position relative to the SAM phantom as in above Step 2.i. Establish radio link in desired radio configuration, with callbox requesting the EUT’s Tx power at power levels described by test sequence 1 generated in Step 1 of Section 3.3.1, conduct point SAR measurement versus time at peak location of the area scan determined in Step 2.i of this section. Once the measurement is done, extract instantaneous point SAR vs time data, $pointSAR(t)$, and convert it into instantaneous 1gSAR or 10gSAR vs. time using Eq. (3a), re-written below:

$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_{P_{limit}}} * 1g_or_10gSAR_{P_{limit}}$$

where, $pointSAR_{P_{limit}}$ is the value determined in Step 2.i, and $pointSAR(t)$ is the instantaneous point SAR measured in Step 2.ii, $1g_or_10gSAR_{P_{limit}}$ is the measured 1gSAR or 10gSAR value listed in Part 1 report.

- iii Perform 100s running average to determine time-averaged 1gSAR or 10gSAR versus time.
- iv Make one plot containing: (a) time-averaged 1gSAR or 10gSAR versus time determined in Step 2.iii of this section, (b) FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.
- v Repeat 2.ii ~ 2.iv for test sequence 2 generated in Step 1 of Section 3.3.1.
- vi Repeat 2.i ~ 2.v for all the technologies and bands selected in Section 3.2.1.

The time-averaging validation criteria for SAR measurement is that, at all times, the time-averaged 1gSAR or 10gSAR versus time shall not exceed FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR (i.e., Eq. (3b)).

4 Test Configurations

4.1 WWAN (sub-6) transmission

The P_{limit} values, corresponding to *SAR_design_target* in operational description, for technologies and bands supported by EUT are derived in Part 1 report and summarized in Table 4-1. Note all P_{limit} power levels entered in Table below correspond to average power levels after accounting for duty cycle in the case of TDD modulation schemes (for e.g., GSM, LTE TDD & Sub6 NR TDD).

*Pmax is used for RF tune up procedure. The maximum allowed output power is equal to Pmax + device uncertainty.

Maximum target power, Pmax, is configured in NV settings in EUT to "limit maximum transmitting power". This power is converted into "peak power in NV settings for TDD schemes". The EUT maximum allowed output power is equal to Pmax + device uncertainty. EFS file plimit level will compare to pmax, when plimit is high than pmax, the power will be limited to Pmax power level.

**All Plimit power levels entered in the Table correspond to average power levels after accounting for duty cycle in the case TDD modulation schemes (for e.g., GSM & LTE TDD & NR TDD).

Based on selection criteria described in Section 3.2.1, the selected technologies/bands for testing time-varying test sequences are listed in Table 4-1, the Reserve_power_margin (dB) for device is set to 3dB in EFS, and is used in Part 2 test.

The radio configurations used in Part 2 test for selected technologies, bands, DSIs and antennas are listed in Table 4-2. The corresponding worst-case radio configuration 1gSAR or 10gSAR values for selected technology/band/DSI are extracted from Part 1 report and are listed in the last column of Table 4-1.

Based on equations (1a), (2a), (3a) and (4a), it is clear that Part 2 testing outcome is normalized quantity, which implies that it can be applied to any radio configuration within a selected technology/band/DSI. Thus, as long as applying the worst-case SAR obtained from the worst radio configuration in Part 1 testing to calculate time-varying SAR exposure in equations (1a), (2a), (3a) and (4a), the accuracy in compliance demonstration remains the same.

Table 4.1. Plimit for supported technologies and bands (P_{limit} in EFS file)

Band	Antenna	DSI1	DSI3	DSI4	DSI6	Pmax*	Total Uncertainty dB (k=2)
GSM850	Ant 0	28.4	24.0	24.0	27.6	24.0	1.00
GSM850	Ant 1	19.5	25.5	26.2	19.5	24.0	1.50
GSM1900	Ant 5	31.8	21.0	21.0	22.3	21.0	1.00
GSM1900	Ant 2	19.0	22.4	26.7	19.0	21.0	1.50
WCDMA V	Ant 0	27.8	24.0	24.0	26.4	24.0	1.00
WCDMA V	Ant 1	18.0	20.0	25.6	18.0	23.5	1.50
WCDMA IV	Ant 3	17.0	23.0	29.0	17.0	24.0	1.00
WCDMA IV	Ant 2	16.5	22.0	25.1	16.5	23.0	1.50
WCDMA IV	Ant 5	29.8	20.5	20.5	20.5	23.0	1.50
WCDMA II	Ant 5	30.6	21.0	21.0	20.5	24.0	1.00
WCDMA II	Ant 3	16.5	21.0	28.6	16.5	24.5	0.50
LTE Band 5	Ant 0	28.4	24.0	24.0	24.0	25.0	0.70
LTE Band 5	Ant 1	19.0	20.5	26.3	19.0	24.5	1.20
LTE Band 26	Ant 0	28.9	24.5	24.5	24.5	25.0	0.70
LTE Band 26	Ant 1	19.0	21.5	27.0	19.0	24.5	1.20
LTE Band 4	Ant 3	18.5	23.5	30.1	18.5	25.0	0.70
LTE Band 4	Ant 2	18.0	22.5	26.7	18.0	24.5	1.20
LTE Band 4	Ant 5	30.9	22.0	22.0	22.0	24.5	1.20
LTE Band 66	Ant 3	18.0	22.0	30.0	18.0	25.0	0.70
LTE Band 66	Ant 2	18.0	22.5	26.5	18.0	24.5	1.20
LTE Band 66	Ant 5	30.7	22.0	22.0	22.0	24.5	1.20
LTE Band 2_Main PA	Ant 3	17.0	21.0	28.6	17.0	24.5	1.00
LTE Band 2_Other PA	Ant 2	16.0	22.0	25.8	16.0	24.0	1.50
LTE Band 2_Main PA	Ant 2	15.5	21.5	25.8	15.5	23.5	1.50
LTE Band 2_Other PA	Ant 5	30.3	21.0	21.0	20.5	24.0	1.00
LTE Band 7_Main PA	Ant 3	16.5	19.5	25.2	16.5	25.0	0.70
LTE Band 7_Other PA	Ant 3	13.0	16.0	26.1	13.0	21.5	1.50
LTE Band 7_Other PA	Ant 2	14.5	17.5	27.1	14.5	23.5	1.50
LTE Band 7_Main PA	Ant 2	15.0	18.0	27.4	15.0	24.0	1.50
LTE Band 7_Other PA	Ant 5	29.0	18.0	18.0	18.0	23.0	1.50
LTE Band 7_Main PA	Ant 5	30.5	19.5	19.5	19.5	24.5	1.00
LTE Band 38_Main PA	Ant 3	16.0	19.5	25.6	16.0	23.0	0.70
LTE Band 38_Other PA	Ant 3	12.0	15.5	25.3	12.0	19.0	1.50
LTE Band 38_Other PA	Ant 2	13.5	17.0	25.7	13.5	21.5	1.50
LTE Band 38_Main PA	Ant 2	14.0	17.5	26.4	14.0	22.0	1.50
LTE Band 38_Other PA	Ant 5	27.8	19.0	19.0	19.0	21.0	1.50
LTE Band 38_Main PA	Ant 5	30.0	20.5	20.5	20.5	22.5	1.00
LTE Band 38_Other PA	Ant 4	15.5	18.5	28.2	15.5	20.5	1.50
LTE Band 38_Main PA	Ant 4	16.0	19.0	28.7	16.0	21.0	1.50
LTE Band 41_Main PA	Ant 3	16.0	19.0	25.7	16.0	23.0	0.70
LTE Band 41_Other PA	Ant 3	12.0	15.0	24.8	12.0	19.0	1.50
LTE Band 41_Other PA	Ant 2	13.5	17.0	26.0	13.5	21.5	1.50
LTE Band 41_Main PA	Ant 2	14.0	17.5	26.5	14.0	22.0	1.50
LTE Band 41_Other PA	Ant 5	28.1	19.0	19.0	19.0	21.0	1.50
LTE Band 41_Main PA	Ant 5	30.2	20.5	20.5	20.5	22.5	1.00
LTE Band 41_Other PA	Ant 4	15.5	19.0	28.0	15.5	20.5	1.50
LTE Band 41_Main PA	Ant 4	16.0	19.5	28.9	16.0	21.0	1.50
LTE Band 42	Ant 6	13.5	17.5	29.4	13.5	23.0	1.00
LTE Band 42	Ant 1	18.0	19.0	29.9	18.0	19.5	1.50
LTE Band 42	Ant 7	15.0	18.0	26.5	15.0	22.0	1.50
LTE Band 42	Ant 8	30.1	16.5	20.5	16.0	21.5	1.50
LTE Band 48	Ant 6	14.0	16.5	29.3	14.0	22.0	1.00
LTE Band 48	Ant 1	17.5	18.5	31.0	17.5	18.5	1.50
LTE Band 48	Ant 7	16.5	18.0	27.3	16.5	21.5	1.50
LTE Band 48	Ant 8	27.4	17.5	19.5	15.5	20.5	1.50
FR1 n5	Ant 0	28.1	24.5	24.5	24.5	25.0	0.70
FR1 n5	Ant 1	19.0	20.0	26.6	19.0	24.5	1.20
FR1 n26	Ant 0	28.5	25.0	25.0	26.4	25.0	0.70
FR1 n26	Ant 1	19.5	21.0	26.6	19.5	24.5	1.20

FR1 n66	Ant 3	18.5	20.5	29.4	18.5	25.0	0.70
FR1 n66	Ant 2	16.5	21.0	25.7	16.5	24.0	1.50
FR1 n66	Ant 5	30.1	22.0	22.0	21.0	24.0	1.50
FR1 n2	Ant 3	17.5	21.0	28.9	17.5	24.5	1.00
FR1 n2	Ant 2	17.0	21.0	26.1	17.0	23.5	1.50
FR1 n7	Ant 3	16.5	19.5	25.0	16.5	25.0	0.70
FR1 n7	Ant 2	15.5	18.5	27.3	15.5	24.0	1.50
FR1 n7	Ant 5	30.1	20.0	20.0	20.0	24.0	1.50
FR1 n38	Ant 3	16.0	19.5	24.5	16.0	25.0	0.70
FR1 n38	Ant 2	14.5	18.0	25.8	14.5	24.0	1.50
FR1 n38	Ant 5	29.5	19.5	19.5	19.5	24.0	1.50
FR1 n38	Ant 4	16.5	19.0	28.6	16.5	23.0	1.50
FR1 n41_PC3	Ant 3	15.5	19.0	24.5	15.5	25.0	0.70
FR1 n41_PC2	Ant 3	15.5	19.0	24.5	15.5	23.0	1.00
FR1 n41_PC3	Ant 2	15.0	18.5	25.2	15.0	24.0	1.50
FR1 n41_PC2	Ant 2	15.0	18.5	25.2	15.0	22.0	1.50
FR1 n41_PC3	Ant 5	29.5	19.5	19.5	19.5	24.0	1.50
FR1 n41_PC2	Ant 5	29.5	19.5	19.5	19.5	22.0	1.50
FR1 n41_PC3	Ant 4	16.5	19.0	27.8	16.5	22.5	1.50
FR1 n41_PC2	Ant 4	16.5	19.0	27.8	16.5	20.5	1.50
FR1 n48	Ant 6	13.0	17.5	27.8	13.0	24.0	1.00
FR1 n48	Ant 1	16.5	20.0	28.6	16.5	20.5	1.50
FR1 n48	Ant 7	17.5	19.0	26.7	17.5	23.5	1.50
FR1 n48	Ant 8	24.7	18.0	20.0	16.0	22.5	1.50
FR1 n77_PC3	Ant 6	12.5	16.0	26.7	12.5	25.0	1.00
FR1 n77_PC2	Ant 6	12.5	16.0	26.7	12.5	24.0	1.50
FR1 n77_PC3	Ant 1	16.0	19.0	26.9	16.0	22.0	1.50
FR1 n77_PC2	Ant 1	16.0	19.0	26.9	16.0	21.0	1.50
FR1 n77_PC3	Ant 7	14.5	17.0	25.1	14.5	23.5	1.50
FR1 n77_PC2	Ant 7	14.5	17.0	25.1	14.5	23.0	1.50
FR1 n77_PC3	Ant 8	21.5	16.5	20.5	16.5	23.5	1.50
FR1 n77_PC2	Ant 8	21.5	16.5	20.5	16.5	22.5	1.50
FR1 n78_PC3	Ant 6	12.0	17.0	26.3	12.0	25.0	1.00
FR1 n78_PC2	Ant 6	12.0	17.0	26.3	12.0	24.0	1.50
FR1 n78_PC3	Ant 1	17.5	19.0	26.9	17.5	21.5	1.50
FR1 n78_PC2	Ant 1	17.5	19.0	26.9	17.5	20.5	1.50
FR1 n78_PC3	Ant 7	14.5	17.5	25.1	14.5	24.0	1.50
FR1 n78_PC2	Ant 7	14.5	17.5	25.1	14.5	23.0	1.50
FR1 n78_PC3	Ant 8	21.5	16.5	20.5	16.5	23.5	1.50
FR1 n78_PC2	Ant 8	21.5	16.5	20.5	16.5	22.5	1.50

GSM/FDD/TDD	Duty Cycle	Time average calculation factor(dB)
GSM 1TX	12.50%	-9.0
GSM 2TX	25%	-6.0
GSM 3TX	37.50%	-4.3
GSM 4TX	50%	-3.0
FDD LTE	100%	0.0
TDD LTE	63.30%	-2.0
NR FDD/TDD	100%	0.0
NR TDD HPUE	50%	-3.0

Trigger Conditions:

Exposure conditions	Trigger Conditions	DSI	SAR design target
Head	Receiver on	DSI1	1g SAR design target
Body Worn (15mm)	Sensor Off / Receiver off	DSI4	1g SAR design target
Hotspot (10mm)	Hotspot On	DSI6	1g SAR design target
Extremity	Sensor On	DSI3	10g SAR design target
	Sensor Off / Receiver off	DSI4	10g SAR design target

Antenna Group:

Antenna Group 0 (AG0)	ANT1 & ANT2 & ANT3 & ANT4 & ANT6 & ANT7 & ANT8 & ANT16 & ANT17
Antenna Group 1 (AG1)	ANT0 & ANT5

Table 4.2. Radio configurations selected for Part 2 test

Test case #	Test scenario	Band	mode	Test Position	Gap (mm)	Antenna	DSI	Channel	Freq (MHz)	Part 1, SAR@Plimit 1-g SAR (W/kg)
1	Time-Varying Tx power transmission	LTE Band 5	10M_QPSK_1_0	Right Side	0mm	Ant 0	6	205525	836.5	0.598
2		LTE Band 5	10M_QPSK_1_0	Right Side	0mm	Ant 0	6	205525	836.5	0.598
3		LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	0.163
4		LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	0.163
5		FR1 n66	40M_QPSK_1_1	Back	15mm	Ant 5	4	349000	1745	0.473
6		FR1 n66	40M_QPSK_1_1	Back	15mm	Ant 5	4	349000	1745	0.473
7		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	0.179
8		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	0.179
9	Call Drop	FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	0.179
10	Tech/band switch	LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	0.163
		WCDMA II	RMC 12.2Kbps	Bottom Side	10mm	Ant 5	6	9262	1852.4	0.827
11	DSI switch	FR1 n78_PC3	100M_QPSK_1_1	Back	15mm	Ant 6	4	633334	3500.01	0.617
		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	0.179
12	Change in Time Window (100-60-100s)	LTE Band 2_Main PA	20M_QPSK_1_0	Left Side	10mm	Ant 3	6	18900	1880	0.185
		LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	0.163
13	Change in Time Window (60-100-60s)	LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	0.163
		LTE Band 2_Main PA	20M_QPSK_1_0	Left Side	10mm	Ant 3	6	18900	1880	0.185
14	LTE VS FR1	LTE Band 2_Other PA	20M_QPSK_1_0	Bottom Side	10mm	Ant 5	6	18900	1880	0.771
		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	0.179
15	Exposure category switch head-non head-head	FR1 n78_PC3	100M_QPSK_1_1	Left Tilted	0mm	Ant 6	1	633334	3500.01	0.665
		FR1 n78_PC3	100M_QPSK_1_1	Back	15mm	Ant 6	4	633334	3500.01	0.617
16	Exposure category switch non head-head-non head	LTE Band 7	20M_QPSK_1_0	Back	15mm	Ant 5	4	21100	2535	0.108
		LTE Band 7	20M_QPSK_1_0	Left Cheek	0mm	Ant 5	1	21100	2535	0.201

Based on the selection criteria described in Section 3.2, the radio configurations for the Tx varying transmission test cases listed in Section 2 are:

1. Technologies and bands for time-varying Tx power transmission: The test case 1~8 listed in Table 4-2 are selected to test with the test sequences defined in Section 3.1 in both time-varying conducted power measurement and time-varying SAR measurement.
2. Technology and band for change in call test: The test case 9 listed in Table 4-2 are selected for performing the call drop test in conducted power setup. 5G NR n78 having the lowest P_{limit} among all technologies and bands
3. Technologies and bands for change in technology/band test: The test case 10 listed in Table 4-2 is selected for handover test from a technology/band to another technology/band, in conducted power setup.
4. Technologies and bands for change in DSI: The test case 11 listed in Table 4-2 is selected for DSI switch test by establishing a call in 5Gnr N78 in DSI =4, and then handing over to DSI =6 exposure scenario in conducted power setup.
5. Technologies and bands for change in time-window/antenna: The test case 12~13 listed in Table 4-2 is selected for time window switch between 60s window (LTE B42) and 100s window (LTE B2) in conducted power setup. LTE B42 is using different antenna from LTE B2, so this test also address the antenna change.
6. Technologies and bands for switch in SAR exposure: The test case 14 listed in Table 4-2 are selected for SAR exposure switching test in one of the supported simultaneous WWAN transmission scenario, i.e., LTE + 5G NR active or LTE Inter-Band Uplink CA in the same 100s time window, in conducted power setup.
7. Exposure Category Switch: The test case 15~16 listed in Table 4-2 is selected for head to non-head to head exposure switch test for 5GNR FR1 n78 and non head-head-non head exposure switch test for LTE B7, so this purpose, there are two tests performed: (a) start with head exposure and switch to non-head exposure and switch back to head exposure, and (b) start with non-head exposure and switch to head exposure and switch back to non-head exposure.

5 Conducted Power Test Results for Sub-6 Smart Transmit Feature Validation

5.1 Measurement setup

The Rohde & Schwarz CMW500 callbox is used in this test. The test setup schematic are shown in Figures 5-1. For single antenna measurement, one port (RF1 COM) of the callbox is connected to the RF port of the EUT using a directional coupler. For antenna & technology switch measurement, two ports (RF1 COM and RF3 COM) of the callbox used for signaling two different technologies are connected to a combiner, which is in turn connected to a directional coupler. The other end of the directional coupler is connected to a splitter to connect to two RF ports of the EUT corresponding to the two antennas of interest. In both the setups, power meter is used to tap the directional coupler for measuring the conducted output power of the EUT. For time averaging validation test (Section 3.3.1), call drop test (Section 3.3.2), and DSI switch test (Section 3.3.4), only RF1 COM port of the callbox is used to communicate with the EUT. For technology/band switch measurement (Section. 3.3.3), both RF1 COM and RF3 COM port of callbox are used to switch from one technology communicating on RF1 COM port to another technology communicating on RF3 COM port. All the path losses from RF port of EUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

LTE+Sub6 NR test setup:

The Keysight UXME7515B callbox is used in this test. If LTE conducted port and Sub6 NR conducted port are same on this EUT (i.e., they share the same antenna), therefore, low-/high-pass filter are used to separate LTE and Sub6 NR signals for power meter measurement via directional couplers, as shown in below Figure 5-1 C (Appendix E – Test Setup Photo).

All the path losses from RF port of DUT to the callbox RF COM port and to the power meter are calibrated and automatically entered as offsets in the callbox and the power meter via test scripts on the PC used to control callbox and power meter.

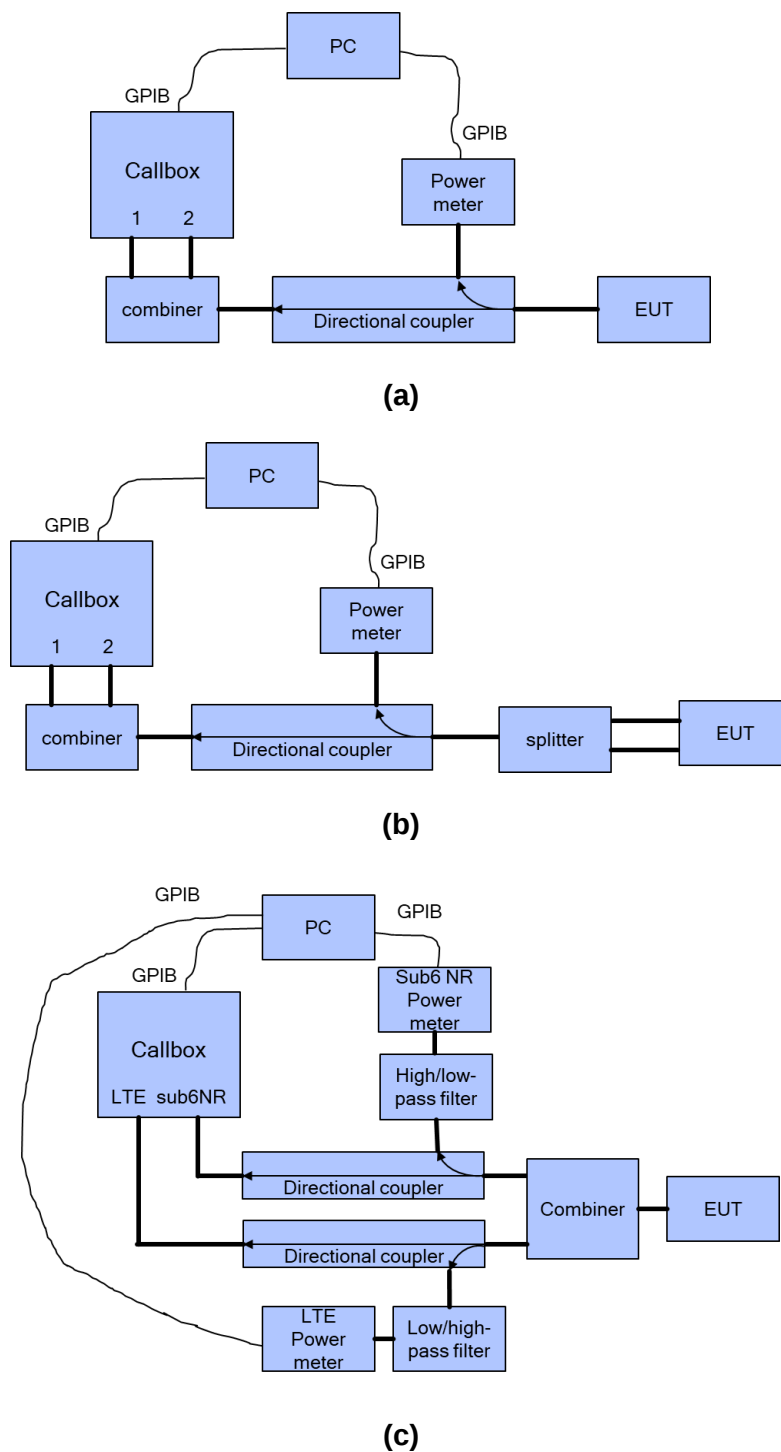


Figure 5-1Conducted power measurement setup

Both the callbox and power meter are connected to the PC using GPIB cables. Two test scripts are custom made for automation, and the test duration set in the test scripts is 500 seconds.

For time-varying Tx power measurement, the PC runs the 1st test script to send GPIB commands to control the callbox's requested power versus time, while at the same time

to record the conducted power measured at EUT RF port using the power meter. The commands sent to the callbox to request power are:

- 0dBm for 100 seconds
- test sequence 1 or test sequence 2 (defined in Section 3.1 and generated in Section 3.2.1), for 360 seconds
- stay at the last power level of test sequence 1 or test sequence 2 for the remaining time.

Power meter readings are periodically recorded every 100ms. A running average of this measured Tx power over 100 seconds is performed in the post-data processing to determine the 100s-time averaged power.

For call drop, technology/band/antenna switch, and DSI switch tests, after the call is established, the callbox is set to request the EUT's Tx power at 0dBm for 100 seconds while simultaneously starting the 2nd test script runs at the same time to start recording the Tx power measured at EUT RF port using the power meter. After the initial 100 seconds since starting the Tx power recording, the callbox is set to request maximum power from the EUT for the rest of the test. Note that the call drop/re-establish, or technology/band/antenna switch or DSI switch is manually performed when the Tx power of EUT is at $P_{reserve}$ level. See Section 3.3 for detailed test procedure of call drop test, technology/band/antenna switch test and DSI switch test.

5.2 P_{limit} and P_{max} measurement results

The measured P_{limit} for all the selected radio configurations given in Table 4-2 are listed in below Table 5-1. P_{max} was also measured for radio configurations selected for testing time-varying Tx power transmission scenarios in order to generate test sequences following the test procedures in Section 3.1.

Table 5.1. Measured Plimit and Pmax of selected radio configurations

Test case #	Test scenario	Band	mode	Test Position	Gap (mm)	Antenna	DSI	Channel	Freq (MHz)	Plimit EFS setting(dBm)	target pmax (dBm)	measured plimit (dBm)	measured pmax (dBm)
1	Time-Varying Tx power transmission	LTE Band 5	10M_QPSK_1_0	Right Side	0mm	Ant 0	6	205525	836.5	24	25	23.42	24.38
2		LTE Band 5	10M_QPSK_1_0	Right Side	0mm	Ant 0	6	205525	836.5	24	25	23.42	24.38
3		LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	13.5	23	13.51	22.98
4		LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	13.5	23	13.51	22.98
5		FR1 n66	40M_QPSK_1_1	Back	15mm	Ant 5	4	349000	1745	22	24	21.78	23.01
6		FR1 n66	40M_QPSK_1_1	Back	15mm	Ant 5	4	349000	1745	22	24	21.78	23.01
7		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	12	25	12.51	24.01
8		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	12	25	12.51	24.01
9	Call Drop	FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	12	25	12.51	24.01
10	Tech/band switch	LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	13.5	23	13.51	22.98
		WCDMA II	RMC 12.2Kbps	Bottom Side	10mm	Ant 5	6	9262	1852.4	20.5	24	20.5	23.51
11	DSI switch	FR1 n78_PC3	100M_QPSK_1_1	Back	15mm	Ant 6	4	633334	3500.01	26.3	25	24.02	24.01
		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	12	25	12.51	24.01
12	Change in Time Window (100-60-100s)	LTE Band 2_Main PA	20M_QPSK_1_0	Left Side	10mm	Ant 3	6	18900	1880	17	24.5	17.24	24.05
		LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	13.5	23	13.51	22.98
13	Change in Time Window (60-100-60s)	LTE Band 42	20M_QPSK_50_0	Top Side	10mm	Ant 6	6	42590	3500	13.5	23	13.51	22.98
		LTE Band 2_Main PA	20M_QPSK_1_0	Left Side	10mm	Ant 3	6	18900	1880	17	24.5	17.24	24.05
14	LTE VS FR1	LTE Band 2_Other PA	20M_QPSK_1_0	Bottom Side	10mm	Ant 5	6	18900	1880	20.5	24	19.6	23.11
		FR1 n78_PC3	100M_QPSK_1_1	Top Side	10mm	Ant 6	6	633334	3500.01	12	25	12.51	24.01
15	Exposure category switch head-non head-head	FR1 n78_PC3	100M_QPSK_1_1	Left Tilted	0mm	Ant 6	1	633334	3500.01	12	25	12.55	24.01
		FR1 n78_PC3	100M_QPSK_1_1	Back	15mm	Ant 6	4	633334	3500.01	26.3	25	24.01	24.01
16	Exposure category switch non head-head-non head	LTE Band 7	20M_QPSK_1_0	Back	15mm	Ant 5	4	21100	2535	19.5	24.5	18.66	23.69
		LTE Band 7	20M_QPSK_1_0	Left Cheek	0mm	Ant 5	1	21100	2535	30.5	24.5	23.69	23.69

5.3 Time-varying Tx power measurement results

The measurement setup is shown in Figures 5-1(a) and 5-1(c). The purpose of the time-varying Tx power measurement is to demonstrate the effectiveness of power limiting enforcement and that the time-averaged Tx power when represented in time-averaged 1gSAR or 10gSAR values does not exceed FCC limit as shown in Eq. (1a) and (1b), rewritten below:

$$1g_or_10gSAR(t) = \frac{conducted_Tx_power(t)}{conducted_Tx_power_P_{limit}} * 1g_or_10gSAR_P_{limit} \quad (1a)$$

$$\frac{\frac{1}{T_{SAR}} \int_{t-T_{SAR}}^t 1g_or_10gSAR(t) dt}{FCC\ SAR\ limit} \leq 1 \quad (1b)$$

where, $conducted_Tx_power(t)$, $conducted_Tx_power_P_{limit}$, and $1g_or_10gSAR_P_{limit}$ correspond to the measured instantaneous conducted Tx power, measured conducted Tx power at P_{limit} , and measured 1gSAR and 10gSAR values at P_{limit} reported in Part 1 test (listed in Table 4-2 of this report as well).

Following the test procedure in Section 3.3, the conducted Tx power measurement for all selected configurations are reported in this section. In all the conducted Tx power plots, the dotted line represents the requested power by callbox (test sequence 1 or test sequence 2), the blue curve represents the instantaneous conducted Tx power measured using power meter, the green curve represents time-averaged power and red line represents the conducted power limit that corresponds to FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

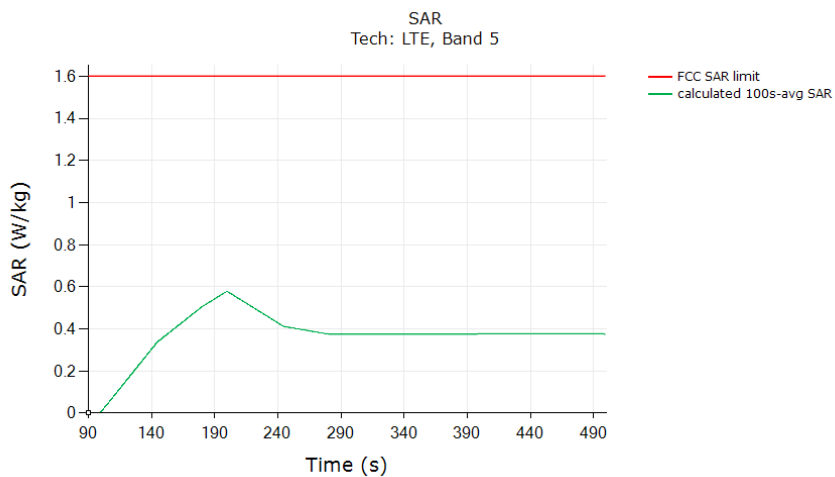
Similarly, in all the 1g or 10gSAR plots (when converted using Eq. (1a)), the green curve represents the 100s/60s-time averaged 1gSAR or 10gSAR value calculated based on instantaneous 1gSAR or 10gSAR; and the red line limit represents the FCC limit of 1.6 W/kg for 1gSAR or 4.0 W/kg for 10gSAR.

The power limiting enforcement is effective in all the tests, and the time-averaged 1gSAR does not exceed the SAR design target + device uncertainty for all the tested technologies/bands. Therefore, Qualcomm Smart Transmit time averaging feature is validated.

5.3.1 LTE Band 5

Test result for test sequence 1:

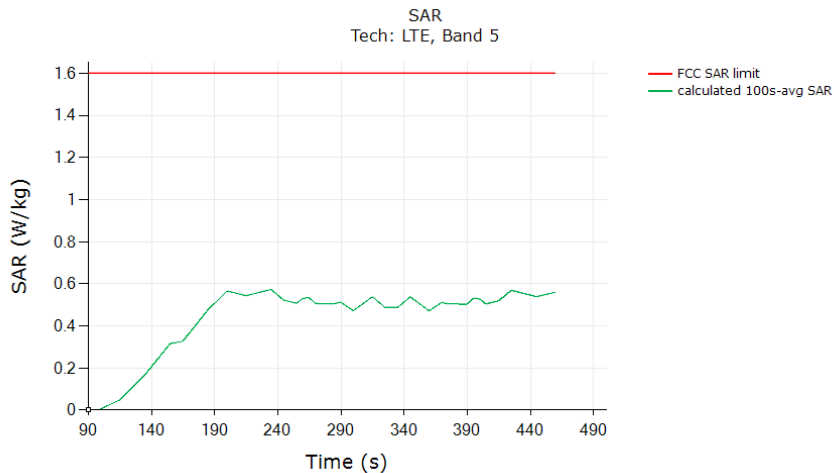
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.578
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

Test result for test sequence 2:

Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6W/kg for 1gSAR:

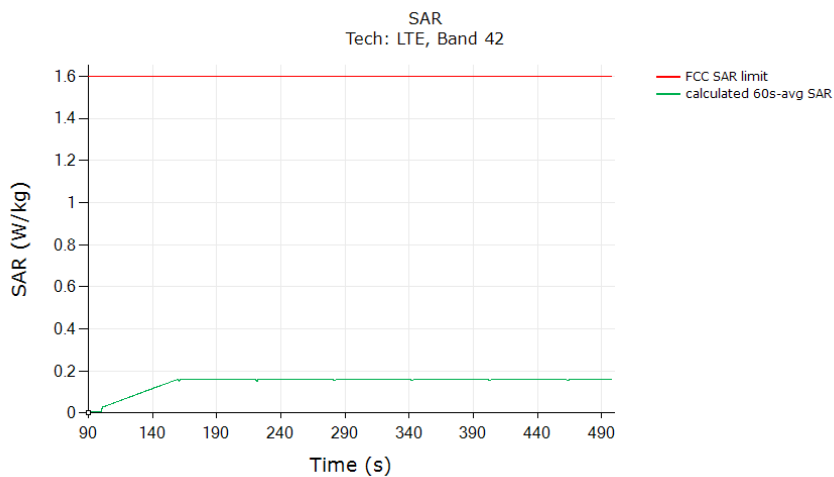


	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.573
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

5.3.2 LTE Band 42

Test result for test sequence 1:

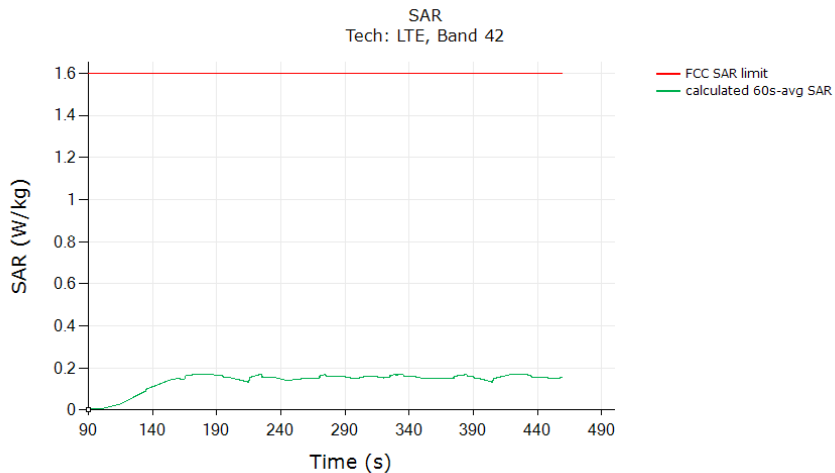
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.161
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

Test result for test sequence 2:

Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6W/kg for 1gSAR:

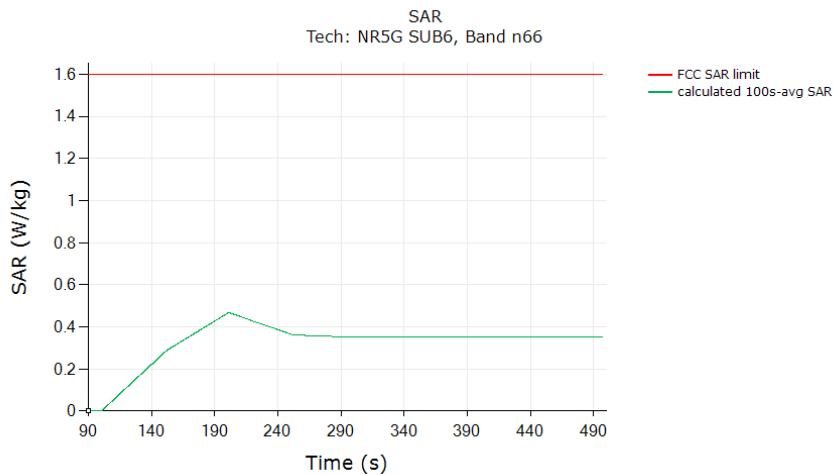


	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.170
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

5.3.3 5G NR n66

Test result for test sequence 1:

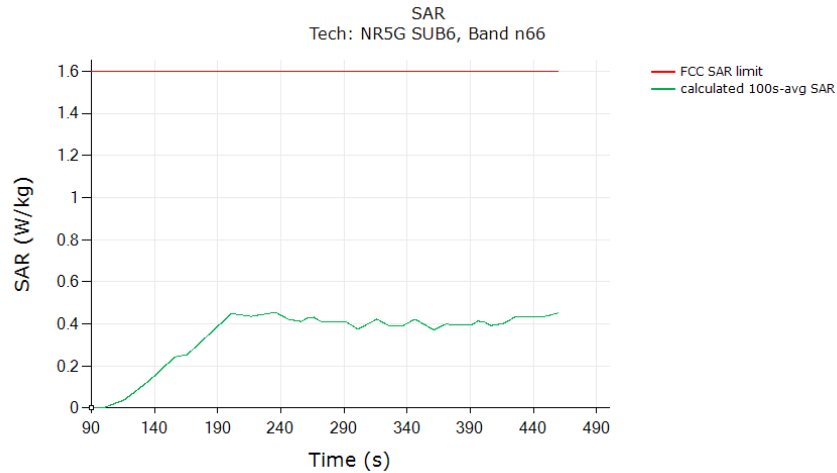
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.467
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

Test result for test sequence 2:

Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6W/kg for 1gSAR:

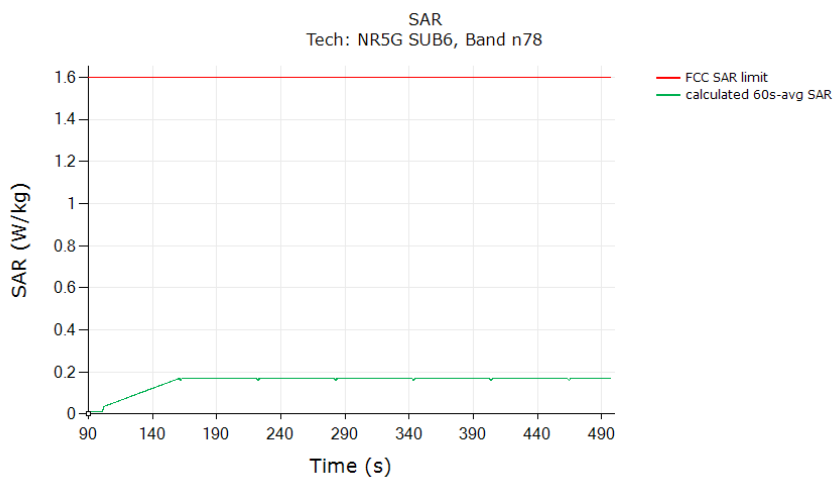


	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.454
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

5.3.4 5G NR n78

Test result for test sequence 1:

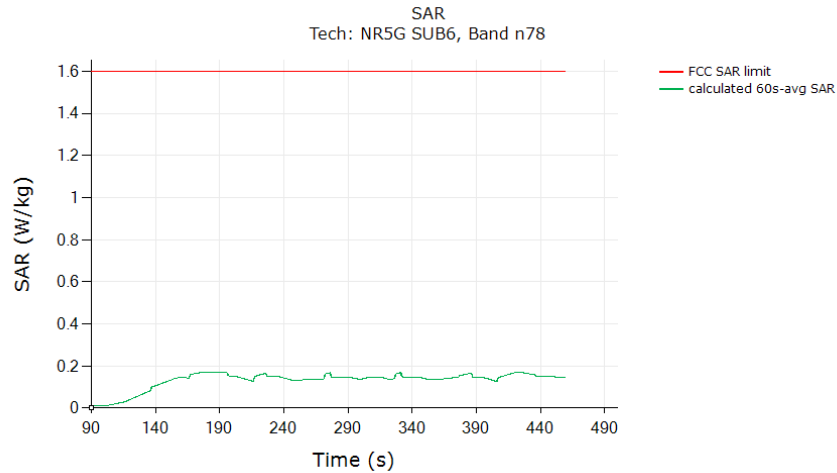
Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.170
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

Test result for test sequence 2:

Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6W/kg for 1gSAR:



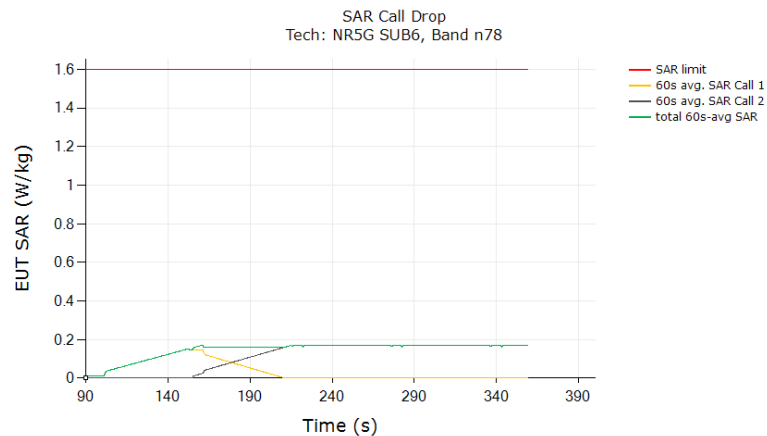
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.170
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

5.4 Change in Call Test Results

This test was measured with 5G NR n78 and with callbox requesting maximum power. The call drop was manually performed when the EUT is transmitting at $Pr_{reserve}$ level as shown in the plot below (dotted black region). The measurement setup is shown in Figure 5-1. The detailed test procedure is described in Section 3.3.2.

Call drop test result:

Above time-averaged conducted Tx power is converted/calculated into time-averaged 1gSAR using Equation (1a) and plotted below to demonstrate that the time-averaged 1gSAR versus time does not exceed the FCC limit of 1.6 W/kg for 1gSAR:



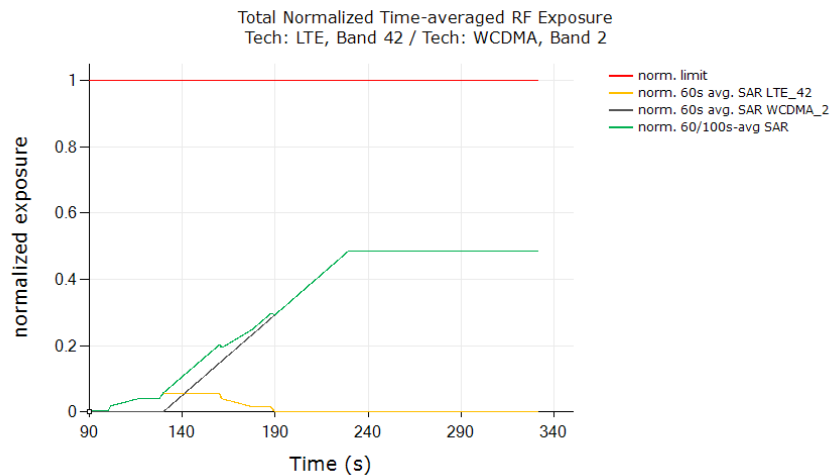
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.171
Validated	

The test result validated the continuity of power limiting in Change in Call scenario.

5.5 Change in technology/band test results

This test was conducted with callbox requesting maximum power, and with antenna & technology switch from LTE B42 to WCDMA B2. Following procedure detailed in Section 3.3.3, and using the measurement setup shown in Figure 5-1(a) and (c).

All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized exposure versus time does not exceed the normalized FCC limit of 1.0:



Exposure Ratio	
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.487
Validated	

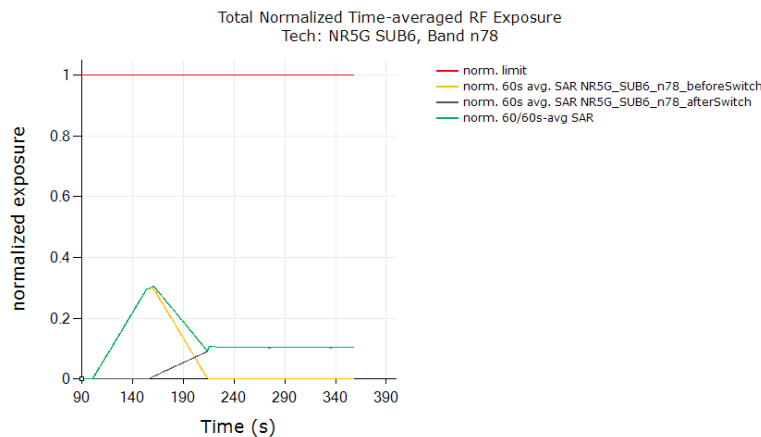
The test result validated the continuity of power limiting in technology/band switch scenario.

5.6 Change in DSI test results

This test was conducted with callbox requesting maximum power, and with DSI switch from 5G NR n78 DSI = 4 to DSI = 6. Following procedure detailed in Section 3.3.5 using the measurement setup shown in Figure 6-1(a) and (c).

Test result for change in DSI:

All the time-averaged conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (6a), (6b) and (6c), and plotted below to demonstrate that the time-averaged normalized Exposure versus time does not exceed the FCC limit of 1 unit.



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.306
Validated	

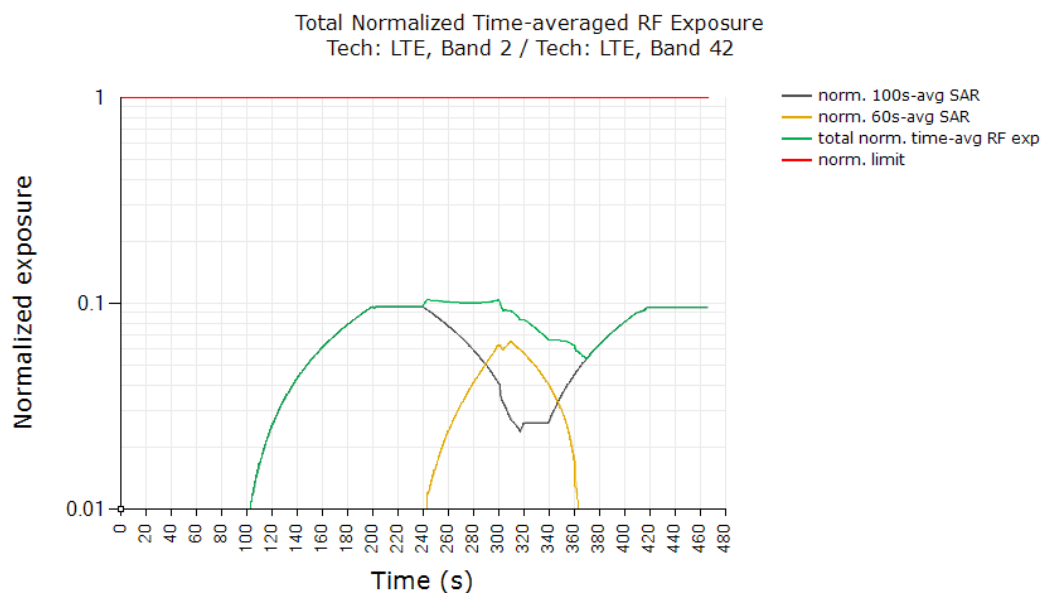
The test result validated the continuity of power limiting in DSI switch scenario.

5.7 Change in Time window / antenna switch test results

5.7.1 Test case 1: transition from LTE B2 to LTE B42 (i.e., 100s to 60s), then back to LTE B2

Test result for change in time-window (from 100s to 60s to 100s):

All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 100s-averaged normalized SAR in LTE B2 as shown in black curve. Similarly, equation (7b) is used to obtain 60s-averaged normalized SAR in LTE B42 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



Exposure Ratio	
FCC normalized Exposure Ratio	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.105
Validated	

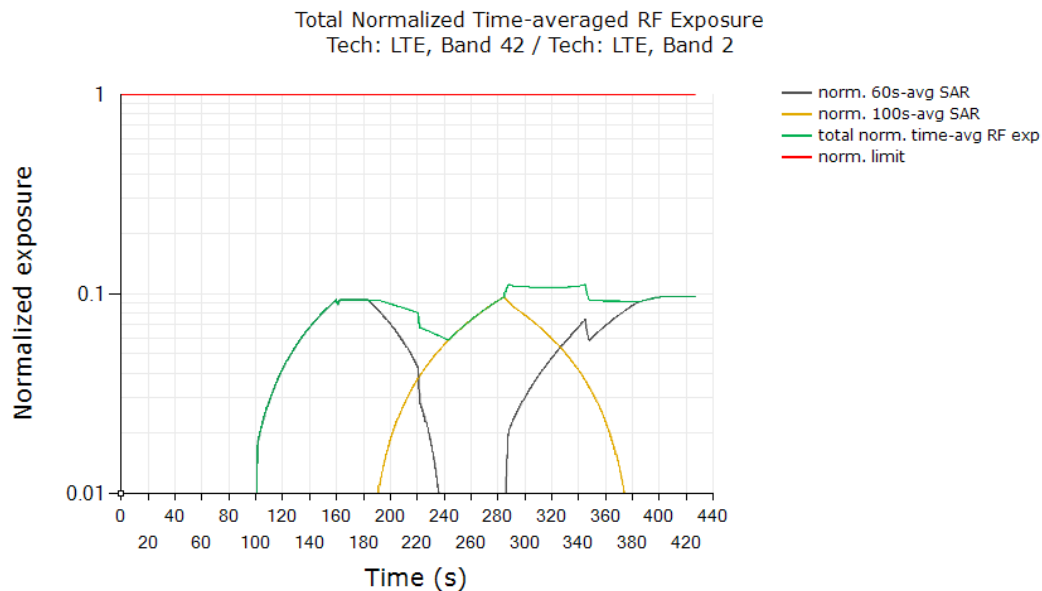
Plot Notes:

Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 100s-to-60s window at ~245s time stamp, and from 60s-to-100s window at ~320s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time averaged normalized RF exposure (green curve) should not exceed normalized SAR_{design_target} + device uncertainty. In this test, with a maximum normalized SAR of 0.105 being ≤ 0.16 ($=0.2/1.6 + 1\text{dB}$ device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.

5.7.2 Test case 2: transition from LTE B42 to LTE B2 (i.e., 60s to 100s), then back to LTE B42

Test result for change in time-window (from 60s to 100s to 60s):

All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the Tx power of device to obtain 60s-averaged normalized SAR in LTE B42 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in LTE B2 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.112
Validated	

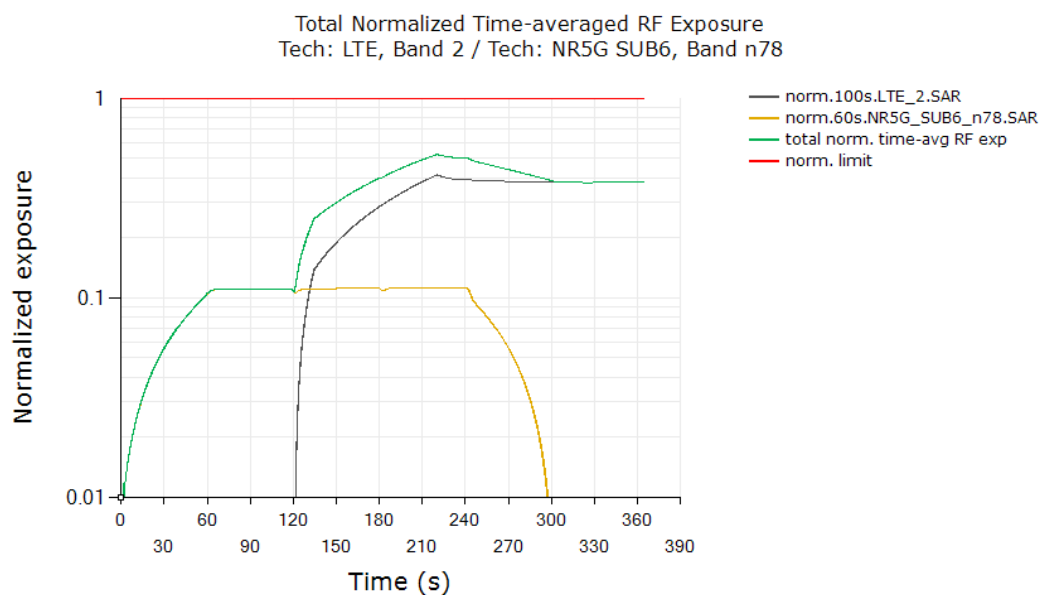
Plot Notes:

Maximum power is requested by callbox for the entire duration of the test, with tech/band switches from 60s-to-100s window at ~185s time stamp, and from 100s-to-60s window at ~290s time stamp. Smart Transmit controls the Tx power during these time-window switches to ensure total time-averaged RF exposure, i.e., sum of black and orange curves given by equation (7c), is always compliant. In time-window switch test, at all times the total time averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target + device uncertainty. In this test, with a maximum normalized SAR of 0.112 being ≤ 0.16 ($=0.2 / 1.6 + 1$ dB device uncertainty), the above test result validated the continuity of power limiting in time-window switch scenario.

5.8 Switch in SAR exposure test results (EN-DC Combination)

This test was conducted with callbox requesting maximum power, and with the EUT in LTE B2 + 5G NR n78 call. Following procedure detailed in Section 3.3.7 and Appendix B.2, and using the measurement setup shown in Figure 5-1, the SAR exposure switch measurement is performed with the EUT in various SAR exposure scenarios.

All the conducted Tx power measurement results were converted into time-averaged normalized SAR values using Equation (7a), (7b) and (7c), and plotted below to demonstrate that the time-averaged normalized SAR versus time does not exceed the FCC limit of 1 unit. Equation (7a) is used to convert the LTE Tx power of device to obtain 100s-averaged normalized SAR in LTE B2 as shown in black curve. Similarly, equation (7b) is used to obtain 100s-averaged normalized SAR in 5G NR n78 as shown in orange curve. Equation (7c) is used to obtain total time-averaged normalized SAR as shown in green curve (i.e., sum of black and orange curves).



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (green curve)	0.526
Validated	

Plot Notes:

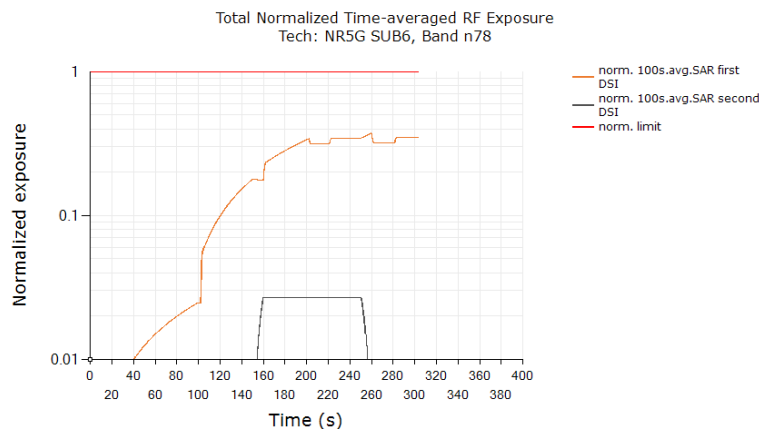
Device starts predominantly in Sub6 NR SAR exposure scenario between 5s and 120s, and in LTE SAR + Sub6 NR SAR exposure scenario between 120s and 240s, and in predominantly in LTE SAR exposure scenario after t=240s. Here, Smart Transmit allocates a maximum of 75% of exposure margin (based on 3dB reserve margin setting) for Sub6 NR. This corresponds to a normalized 1gSAR exposure value = 75% * 0.179 W/kg measured SAR at Sub6 NR Plimit / 1.6W/kg limit = 0.112 + "+1dB~ -1dB" device related uncertainty (see orange curve between 5s~120s). For predominantly LTE SAR exposure scenario, maximum normalized 1gSAR exposure should correspond to 100% exposure margin = 0.771 W/kg measured SAR at LTE Plimit / 1.6W/kg limit = 0.482 "+1dB~ -1dB" device related uncertainty (see black curve after t = 180s). Additionally, in SAR exposure switch test, at all times the total time-averaged normalized RF exposure (green curve) should not exceed normalized SAR_design_target + device uncertainty. In this test, with a maximum normalized SAR of 0.526 being ≤ 0.56 ($=0.71/1.6 + 1$ dB device uncertainty), the above test result validated the continuity of power limiting in SAR exposure switch scenario.

5.9 Exposure Category Switch Test results

In case of head to non-head to head exposure switch test for 5GNR FR1 n78, 'first DSI' in section 3.3.9 test procedure refers to head DSI and 'second DSI' refers to non-head DSI. Similarly, in case of non-head to head to non-head exposure switch test LTE B7, 'first DSI' in section 3.3.9 test procedure refers to non-head DSI and 'second DSI' refers to head DSI.

The validation criteria is, at all times, the time-averaged normalized exposure versus time shall not exceed the normalized limit of 1.0 for both first & second DSIs (i.e., both head exposure category and non-head exposure category).

Test case 1: For head to non-head to head exposure switch test, the time-averaged normalized RF exposure in head exposure DSI (orange curve) did not exceed normalized limit of 1.0 at all times.

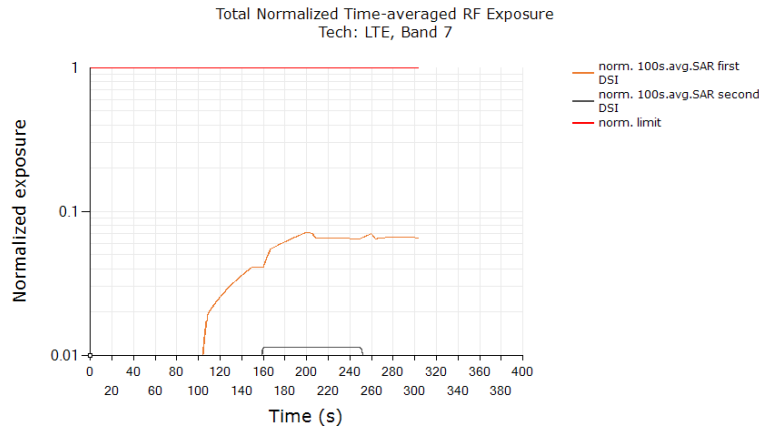


	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (orange curve)	0.373
Validated	

Plot Notes:

Maximum Tx power is requested at t=100s, time-averaged exposure in head DSI gradually increases until t~150s where the device is switched from head exposure DSI (first DSI, orange curve) to non-head exposure DSI (second DSI, black curve) as evident from increase in exposure of black curve and no change in orange curve between t~150s and t~160s. At t~150s, device is switched back from non-head exposure to head exposure as evident from increase in exposure of orange curve and no change in black curve. In this test, the time-averaged normalized RF exposure in head exposure DSI (orange curve) did not exceed normalized limit of 1.0 at all times, and is less than normalized measured 1gSAR of 0.373 being ≤ 0.68 ($=0.87 / 1.6 + 1$ dB device uncertainty), validating the exposure continuity when switching between head exposure and non-head exposure categories.

Test case 2: For non-head to head to non-head exposure switch test, the time-averaged normalized RF exposure in non-head exposure DSI (orange curve) did not exceed normalized limit of 1.0 at all times.



	Exposure Ratio
FCC normalized Exposure Ratio limit	1.0
Max time averaged normalized Exposure Ratio (orange curve)	0.072
Validated	

Plot Notes:

Maximum Tx power is requested at t=100s, time-averaged exposure in non-head DSI gradually increases until t~150s where the device is switched from non-head exposure DSI (first DSI, orange curve) to head exposure DSI (second DSI, black curve) as evident from increase in exposure of black curve and no change in orange curve between t~150s and t~160s. At t~150s, device is switched back from head exposure to non-head exposure as evident from increase in exposure of orange curve and no change in black curve. In this test, the time-averaged normalized RF exposure in non-head exposure DSI (orange curve) did not exceed normalized limit of 1.0 at all times, and is less than normalized measured 1gSAR of 0.072 being ≤ 0.68 ($=0.87 / 1.6 + 1$ dB device uncertainty), validating the exposure continuity when switching between non-head exposure and head exposure categories.

6 SAR Test Results for Sub-6 Smart Transmit Feature Validation

6.1 Measurement setup

The measurement setup is similar to normal SAR measurements (see Appendix E). The difference in SAR measurement setup for time averaging feature validation is that the callbox is signaling in close loop power control mode (instead of requesting maximum power in open loop control mode) and callbox is connected to the PC using GPIB so that the test script executed on PC can send GPIB commands to control the callbox's requested power over time (test sequence). The same test script used in conducted setup for time-varying Tx power measurements is also used in this section for running the test sequences during SAR measurements, and the recorded values from the disconnected power meter by the test script were discarded.

As mentioned in Section 3.4, for EUT to follow TPC command sent from the callbox wirelessly, the "path loss" between callbox antenna and the EUT needs to be very well calibrated. Since the SAR chamber is in uncontrolled environment, precautions must be taken to minimize the environmental influences on "path loss". Similarly, in the case of time-varying SAR measurements in Sub6 NR (with LTE as anchor), "path loss" between callbox antenna and the EUT needs to be carefully calibrated for both LTE link as well as for Sub6 NR link.

The EUT is placed in worst-case position according to Table 4-2.

6.2 SAR measurement results for time-varying Tx power transmission scenario

Following Section 3.4 procedure, time-averaged SAR measurements are conducted using EX3DV4 probe at peak location of area scan over 500 seconds. cDASY6 system verification for SAR measurement is provided in Appendix C, and the associated SPEAG certificates are attached in Appendix D.

SAR probe integration times depend on the communication signal being tested. Integration times used by SPEAG for their probe calibrations can be downloaded from here (integration time is listed on the bottom of the first page for each tech):

<https://www.speag.com/assets/downloads/services/cs/UIDSummary171205.pdf>

Since the sampling rate used by cDASY6 for pointSAR measurements is not in user control, the number of points in 100s or 60s interval is determined from the scan duration setting in cDASY6 time-average pointSAR measurement by (100s or 60s / cDASY6_scan_duration * total number of pointSAR values recorded). Running average is performed over these number of points in excel spreadsheet to obtain 100s-/60s-averaged pointSAR.

Following Section 3.4, for each of selected technology/band (listed in Table 4-2):

8. With *Reserve_power_margin* set to 0 dB, area scan is performed at P_{limit} , and time-averaged pointSAR measurements are conducted to determine the pointSAR at P_{limit} at peak location, denoted as $pointSAR_{P_{limit}}$.
9. With *Reserve_power_margin* set to actual (intended) value, two more time-averaged pointSAR measurements are performed at the same peak location for test sequences 1 and 2.

To demonstrate compliance, all the pointSAR measurement results were converted into 1gSAR or 10gSAR values by using Equation (3a), rewritten below:

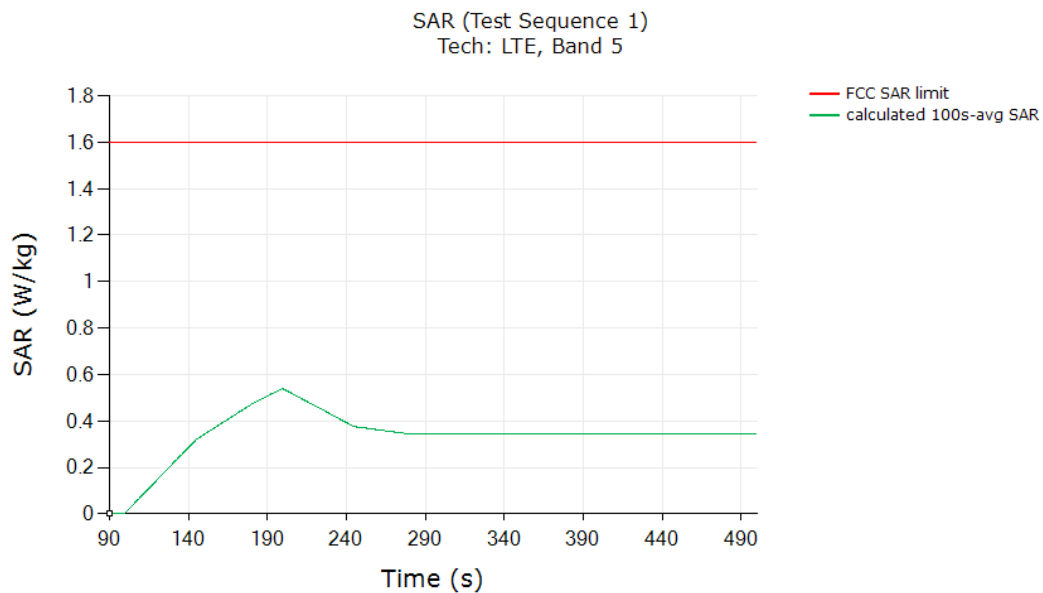
$$1g_or_10gSAR(t) = \frac{pointSAR(t)}{pointSAR_{P_{limit}}} * 1g_or_10gSAR_{P_{limit}} \quad (3a)$$

where, $pointSAR(t)$, $pointSAR_{P_{limit}}$, and $1g_or_10gSAR_{P_{limit}}$ correspond to the measured instantaneous point SAR, measured point SAR at P_{limit} from above step 1 and 2, and measured 1gSAR or 10gSAR values at P_{limit} obtained from Part 1 report and listed in Table 4-2 in Section 5.1 of this report.

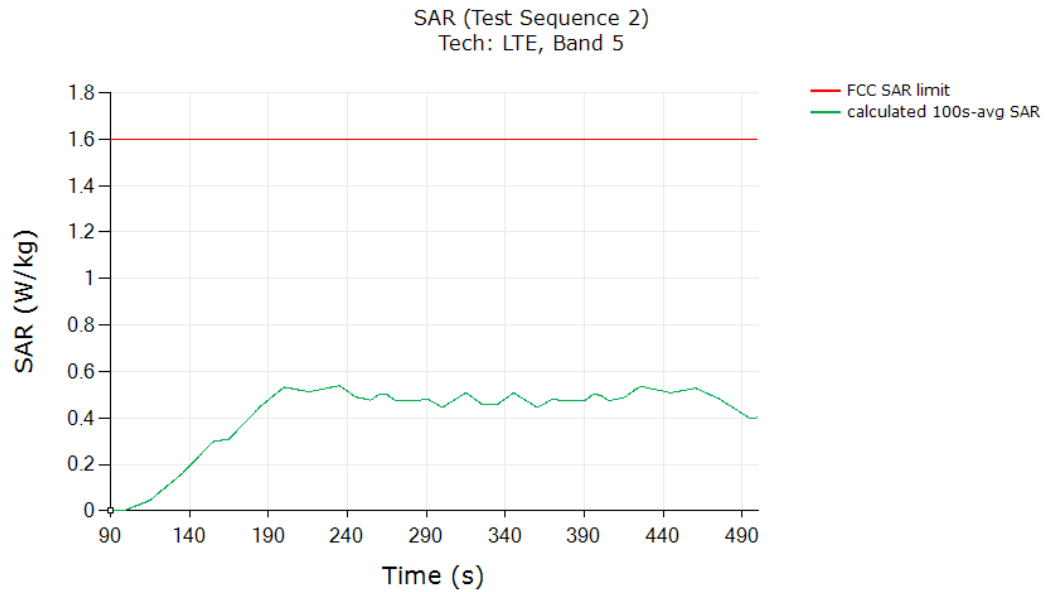
The power limiting enforcement is effective in all the tests, and the time-averaged 1gSAR does not exceed the SAR design target + device uncertainty for all the tested technologies/bands. Therefore, Qualcomm Smart Transmit time averaging feature is validated.

6.2.1 LTE B5 SAR test results

SAR test results for test sequence 1:



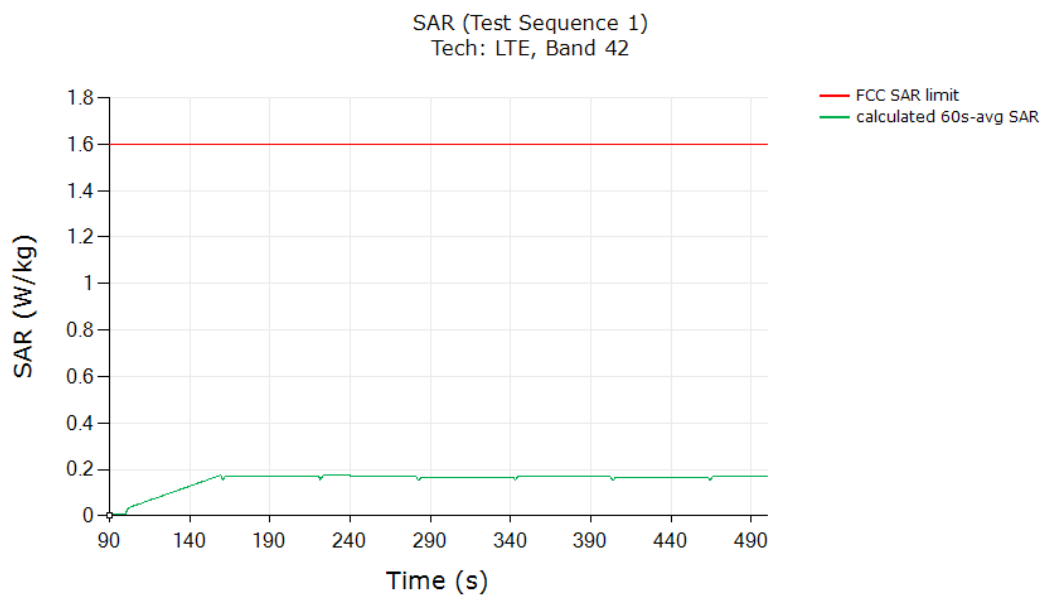
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.539
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

SAR test results for test sequence 2:

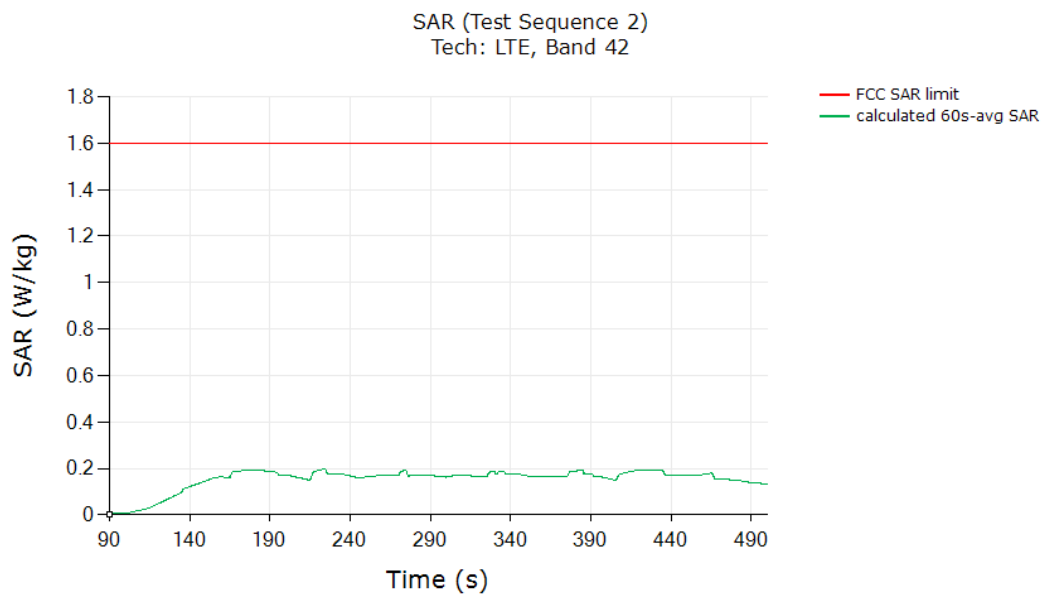
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.538
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

6.2.2 LTE B42 SAR test results

SAR test results for test sequence 1:



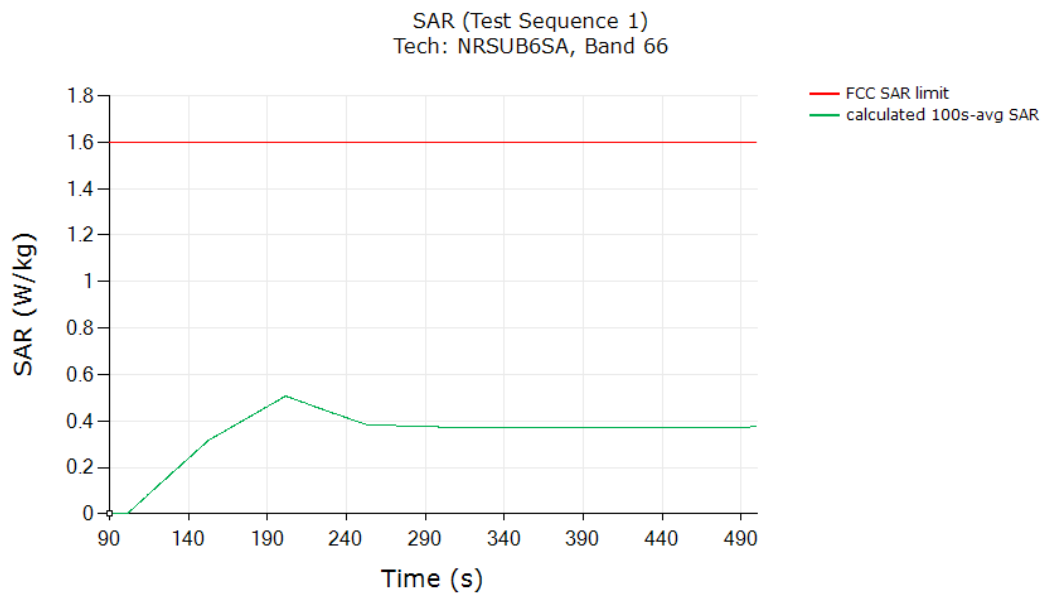
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.175
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

SAR test results for test sequence 2:

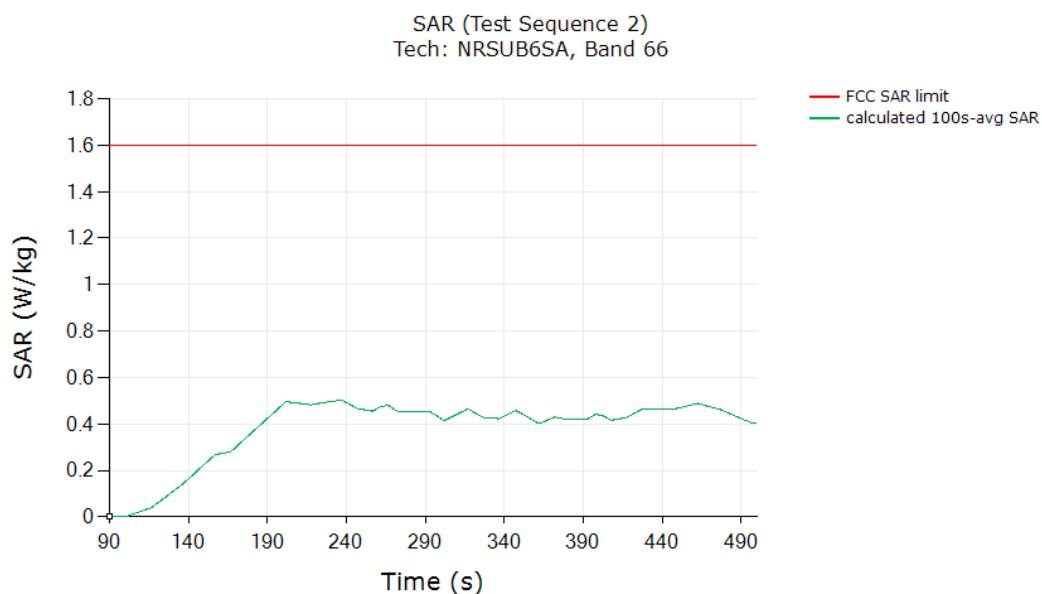
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.198
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

6.2.3 5G NR n66 SAR test results

SAR test results for test sequence 1:



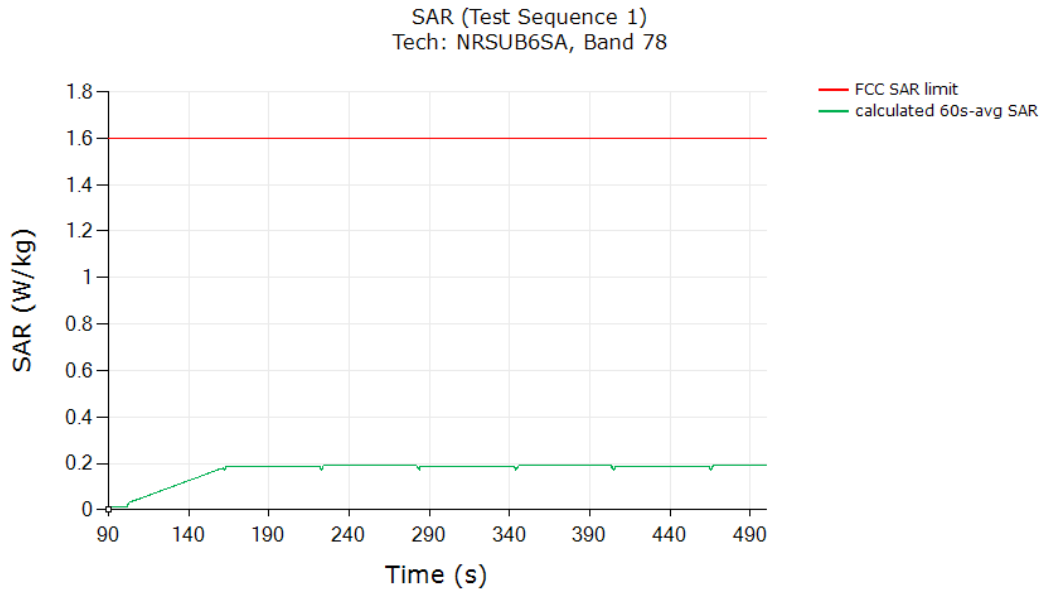
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.506
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

SAR test results for test sequence 2:

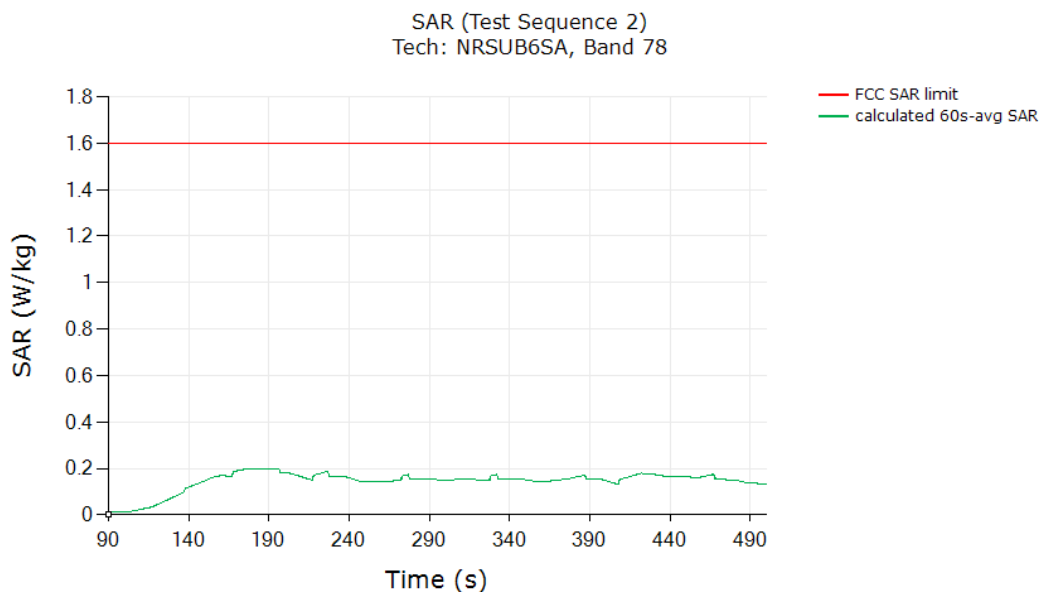
	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.502
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

6.2.4 5G NR n78 SAR test results

SAR test results for test sequence 1:



	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.192
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

SAR test results for test sequence 2:

	(W/kg)
FCC 1gSAR limit	1.6
Max time averaged 1gSAR (green curve)	0.198
Validated: Max time averaged SAR (green curve) does not exceed SAR design target + device uncertainty	

7 Conclusions

Qualcomm Smart Transmit feature employed in FCC ID: 2AFZZRKC7G has been validated through the conducted power measurement (as demonstrated in Chapters 5), as well as SAR measurement (as demonstrated in Chapters 6).

As demonstrated in this report, the power limiting enforcement is effective and the total normalized time-averaged RF exposure does not exceed 1.0 for all the transmission scenarios described in Section 2. Therefore, the EUT complies with FCC RF exposure requirement

Appendix A. Test Sequences

1. Test sequence is generated based on below parameters of the EUT:
 - a. Measured maximum power (P_{max})
 - b. Measured Tx_power_at_SAR_design_target (P_{limit})
 - c. Reserve_power_margin (dB)
 - $P_{reserve}$ (dBm) = measured P_{limit} (dBm) – Reserve_power_margin (dB)
 - d. SAR_time_window (100s for FCC)
2. Test Sequence 1 Waveform:

Based on the parameters above, the Test Sequence 1 is generated with one transition between high and low Tx powers. Here, high power = P_{max} ; low power = $P_{max}/2$, and the transition occurs after 80 seconds at high power P_{max} . As long as the power enforcement is taking into effective during one 100s/60s time window, the validation test with this defined test sequence 1 is valid, otherwise, select other radio configuration (band/DSI within the same technology group) having lower P_{limit} for this test. The Test sequence 1 waveform is shown below:

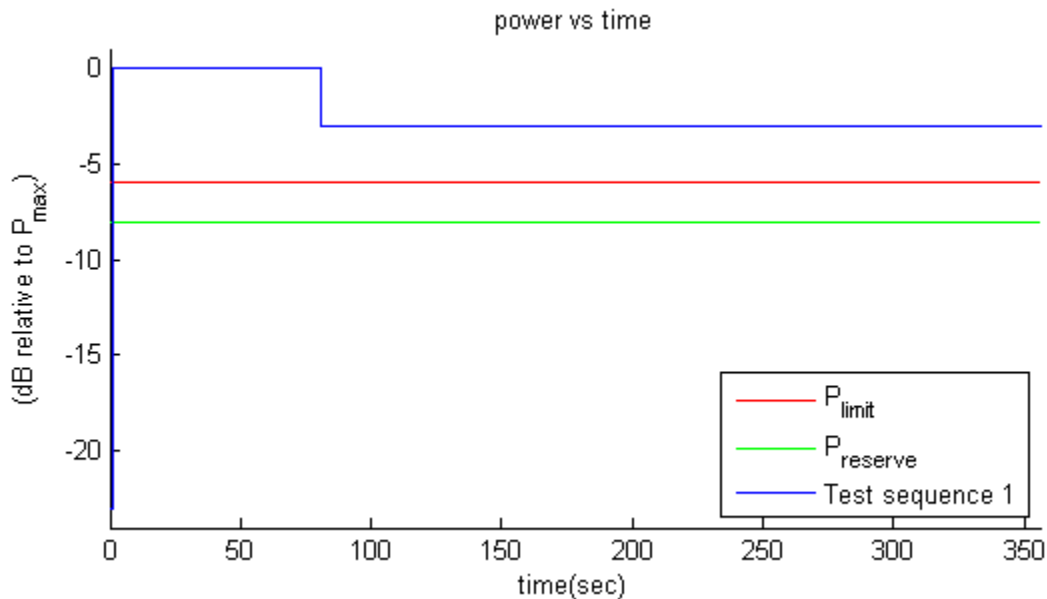


Figure 0-1 Test sequence 1 waveform

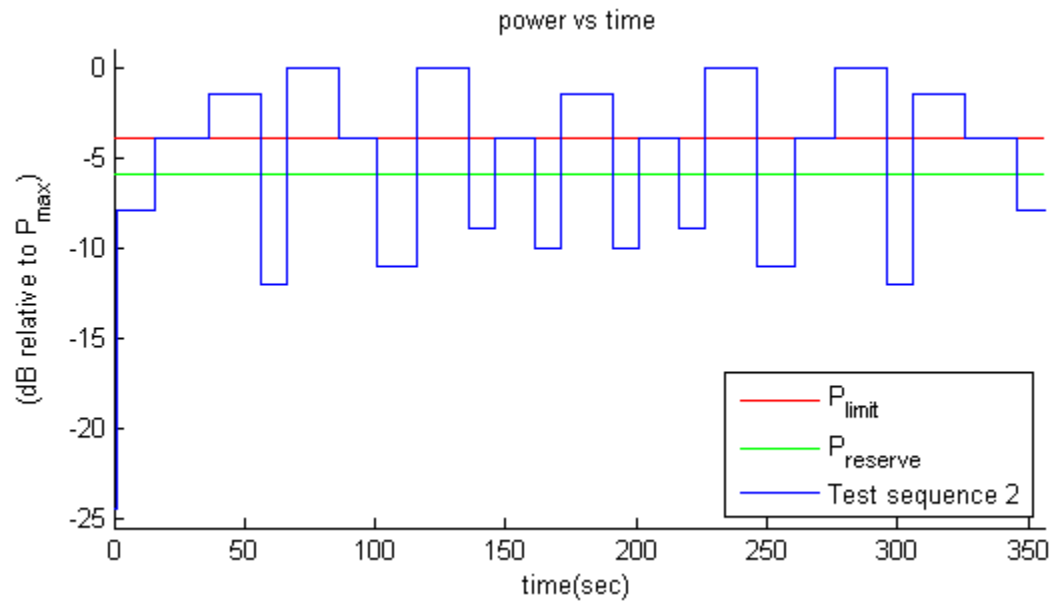
3. Test Sequence 2 Waveform:

Based on the parameters in A-1, the Test Sequence 2 is generated as described in Table 10-1, which contains two 170 second-long sequences (yellow and green highlighted rows) that are mirrored around the center row of 20s, resulting in a total duration of 360 seconds:

Table 0-1 Test Sequence 2

Time duration (seconds)	dB relative to P_{limit} or $P_{reserve}$
15	$P_{reserve} - 2$
20	P_{limit}
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 6$
20	P_{max}
15	P_{limit}
15	$P_{reserve} - 5$
20	P_{max}
10	$P_{reserve} - 3$
15	P_{limit}
10	$P_{reserve} - 4$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
10	$P_{reserve} - 4$
15	P_{limit}
10	$P_{reserve} - 3$
20	P_{max}
15	$P_{reserve} - 5$
15	P_{limit}
20	P_{max}
10	$P_{reserve} - 6$
20	$(P_{limit} + P_{max})/2$ averaged in mW and rounded to nearest 0.1 dB step
20	P_{limit}
15	$P_{reserve} - 2$

The Test Sequence 2 waveform is shown in Figure A-2.



Appendix B. Test Procedures for sub6 NR + LTE Radio

Appendix B provides the test procedures for validating Qualcomm Smart Transmit feature for LTE + Sub6 NR non-standalone (NSA) mode transmission scenario, where sub-6GHz LTE link acts as an anchor.

1 Time-varying Tx power test for sub6 NR in NSA mode

Follows Section 3.2.1 to select test configurations for time-varying test. This test is performed with two pre-defined test sequences (described in Section 3.1) applied to Sub6 NR (with LTE on all-down bits or low power for the entire test after establishing the LTE+Sub6 NR call with the callbox). Follow the test procedures described in Section 3.3.1 to demonstrate the effectiveness of power limiting enforcement and that the time averaged Tx power of Sub6 NR when converted into 1gSAR values does not exceed the regulatory limit at all times (see Eq. (1a) and (1b)). Sub6 NR response to test sequence1 and test sequence2 will be similar to other technologies (say, LTE), and are shown in Sections 5.3.9 and 5.3.10.

2 Switch in SAR exposure between LTE vs. Sub6 NR during transmission

This test is to demonstrate that Smart Transmit feature accurately accounts for switching in exposures among SAR for LTE radio only, SAR from both LTE radio and sub6 NR, and SAR from sub6 NR only scenarios, and ensures total time-averaged RF exposure compliance with FCC limit.

Test procedure:

1. Measure conducted Tx power corresponding to P_{limit} for LTE and sub6 NR in selected band. Test condition to measure conducted P_{limit} is:
 - Establish device in call with the callbox for LTE in desired band. Measure conducted Tx power corresponding to LTE P_{limit} with Smart Transmit enabled and Reserve_power_margin set to 0 dB, callbox set to request maximum power.
 - Repeat above step to measure conducted Tx power corresponding to Sub6 NR P_{limit} . If testing LTE+Sub6 NR in non-standalone mode, then establish LTE+Sub6 NR call with callbox and request all down bits for radio1 LTE. In this scenario, with callbox requesting maximum power from Sub6 NR, measured conducted Tx power corresponds to radio2 P_{limit} (as radio1 LTE is at all-down bits)
2. Set Reserve_power_margin to actual (intended) value with EUT setup for LTE + Sub6 NR call. First, establish LTE connection in all-up bits with the callbox, and then Sub6 NR connection is added with callbox requesting UE to transmit at maximum power in Sub6 NR. As soon as the Sub6 NR connection is established, request all-down bits on LTE link (otherwise, Sub6 NR will not have sufficient RF exposure margin to sustain the call with LTE in all-up bits). Continue LTE (all-down bits)+Sub6 NR transmission for more than one time-window duration to test predominantly Sub6 NR SAR exposure scenario (as SAR exposure is negligible from all-down bits in

- LTE). After at least one time-window, request LTE to go all-up bits to test LTE SAR and Sub6 NR SAR exposure scenario. After at least one more time-window, drop (or request all-down bits) Sub6 NR transmission to test predominantly LTE SAR exposure scenario. Continue the test for at least one more time-window. Record the conducted Tx powers for both LTE and Sub6 NR for the entire duration of this test.
3. Once the measurement is done, extract instantaneous Tx power versus time for both LTE and Sub6 NR links. Similar to technology/band switch test in Section 3.3.3, convert the conducted Tx power for both these radios into 1gSAR value (see Eq. (6a) and (6b)) using corresponding technology/band P_{limit} measured in Step 1, and then perform 100s running average to determine time-averaged 1gSAR versus time as illustrated in Figure 3-1.
 4. Make one plot containing: (a) instantaneous Tx power versus time measured in Step 2.
 5. Make another plot containing: (a) instantaneous 1gSAR versus time determined in Step 3, (b) computed time-averaged 1gSAR versus time determined in Step 3, and (c) corresponding regulatory $1gSAR_{limit}$ of 1.6W/kg.

The validation criteria is, at all times, the time-averaged 1gSAR versus time shall not exceed the regulatory $1gSAR_{limit}$ of 1.6W/kg.

Appendix C. cDASY6 System Verification

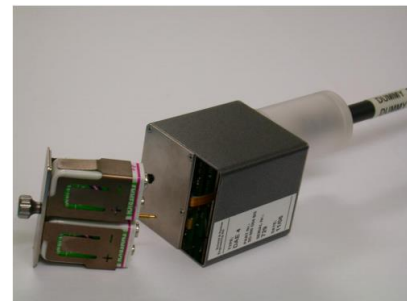
1. SAR E-Field Probe

Construction	Symmetric design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)	
Frequency	10 MHz – >6 GHz Linearity: ± 0.2 dB (30 MHz – 6 GHz)	
Directivity	± 0.3 dB in TSL (rotation around probe axis) ± 0.5 dB in TSL (rotation normal to probe axis)	
Dynamic Range	10 μ W/g – >100 mW/g Linearity: ± 0.2 dB (noise: typically <1 μ W/g)	
Dimensions	Overall length: 337 mm (tip: 20 mm) Tip diameter: 2.5 mm (body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	

2. Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200 MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80 dB.



Test Equipment List

Manufacturer	Name of Equipment	Type/Model	Serial Number	Calibration	
				Last Cal.	Due Date
SPEAG	835MHz System Validation Kit ⁽²⁾	D835V2	4d167	Nov. 24, 2022	Nov. 22, 2024
SPEAG	1750MHz System Validation Kit ⁽²⁾	D1750V2	1112	Jun. 22, 2022	Jun. 19, 2025
SPEAG	3500MHz System Validation Kit ⁽²⁾	D3500V2	1014	Jan. 17, 2022	Jan. 14, 2025
SPEAG	Data Acquisition Electronics	DAE4	1776	Feb. 13, 2024	Feb. 12, 2025
SPEAG	Data Acquisition Electronics	DAE4ip	1800	Jun. 18, 2024	Jun. 17, 2025
SPEAG	Dosimetric E-Field Probe	EX3DV4	7590	Mar. 19, 2024	Mar. 18, 2025
SPEAG	Dosimetric E-Field Probe	EX3DV4	7793	Mar. 01, 2024	Feb. 28, 2025
Testo	Hygro meter	608-H1	45196600	Nov. 02, 2023	Nov. 01, 2024
Testo	Hygro meter	608-H1	45207528	Nov. 02, 2023	Nov. 01, 2024
Keysight	5G Wireless Test Platform	E7515B	MY58300712	Apr. 22, 2024	Apr. 21, 2025
R&S	Wideband Radio Communication Tester	CMW500	115793	Nov. 20, 2023	Nov. 19, 2024
Anritsu	Signal Generator	MG3710A	6201502524	Sep. 24, 2024	Sep. 23, 2025
Anritsu	Power Meter	ML2496A	2119003	Jul. 16, 2024	Jul. 15, 2025
Anritsu	Power Sensor	MA2411B	1911334	Jul. 15, 2024	Jul. 14, 2025
Anritsu	Power Sensor	MA2411B	1911333	Jul. 15, 2024	Jul. 14, 2025
R&S	Power Sensor	NRP8S	109688	Sep. 17, 2024	Sep. 16, 2025
R&S	Power Sensor	NRP8S	114191	May. 13, 2024	May. 12, 2025
Mini-Circuits	Power Amplifier	ZVE-8G+	D120604	Oct. 16, 2024	Oct. 15, 2025
Mini-Circuits	Power Amplifier	ZHL-42W+	715701915	May. 17, 2024	May. 16, 2025
ATM	Dual Directional Coupler	C122H-10	P610410z-02	Note 1	
Warison	Directional Coupler	WCOU-10-50S-10	WR889BMC4B1	Note 1	
Woken	Attenuator 1	WK0602-XX	N/A	Note 1	
PE	Attenuator 2	PE7005-10	N/A	Note 1	
PE	Attenuator 3	PE7005- 3	N/A	Note 1	

General Note:

1. Prior to system verification and validation, the path loss from the signal generator to the system check source and the power meter, which includes the amplifier, cable, attenuator and directional coupler, was measured by the network analyzer. The reading of the power meter was offset by the path loss difference between the path to the power meter and the path to the system check source to monitor the actual power level fed to the system check source.
2. Referring to KDB 865664 D01v01r04, the dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.
3. The justification data of dipole D750V3, SN: 1107, D1750V2, SN: 1112, D1900V2, SN: 5d041 can be found in appendix D. The return loss is < -20dB, within 20% of prior calibration, the impedance is within 5 ohm of prior calibration.

6. SAR system verification and validation

6.1 Tissue Verification

The following tissue formulations are provided for reference only as some of the parameters have not been thoroughly verified. The composition of ingredients may be modified accordingly to achieve the desired target tissue parameters required for routine SAR evaluation.

Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Preventol (%)	DGBE (%)	Conductivity (σ)	Permittivity (ϵ_r)
750	41.1	57.0	0.2	1.4	0.2	0	0.89	41.9
835	40.3	57.9	0.2	1.4	0.2	0	0.90	41.5
900	40.3	57.9	0.2	1.4	0.2	0	0.97	41.5
1800, 1900, 2000	55.2	0	0	0.3	0	44.5	1.40	40.0
2450	55.0	0	0	0	0	45.0	1.80	39.2
2600	54.8	0	0	0.1	0	45.1	1.96	39.0

Simulating Liquid for 5GHz, Manufactured by SPEAG

Ingredients	(% by weight)
Water	64~78%
Mineral oil	11~18%
Emulsifiers	9~15%
Additives and Salt	2~3%

<Tissue Check Results>

Frequency (MHz)	Liquid Temp. (°C)	Conductivity (σ)	Permittivity (ϵ_r)	Conductivity Target (σ)	Permittivity Target (ϵ_r)	Delta (σ) (%)	Delta (ϵ_r) (%)	Limit (%)	Date
835	22.5	0.942	41.800	0.90	41.50	4.67	0.72	±5	2024/10/24
1750	22.4	1.370	40.700	1.37	40.10	0.00	1.50	±5	2024/10/24
3500	22.7	2.970	38.300	2.91	37.90	2.06	1.06	±5	2024/10/17



6.2 System Verification

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10 %. Below table shows the target SAR and measured SAR after normalized to 1W input power. The table below indicates the system performance check can meet the variation criterion and the plots can be referred to Appendix C.

<System Verification Results>

Test Site	Date	Frequency (MHz)	Input Power (mW)	Dipole S/N	Probe S/N	DAE S/N	Measured 1g SAR (W/kg)	Targeted 1g SAR (W/kg)	Normalized 1g SAR (W/kg)	Deviation (%)
SAR-5GNR01-HY	2024/10/24	835	50	D835V2-4d167	EX3DV4 - SN7793	DAE4ip Sn1800	0.514	9.800	10.28	4.90
SAR-5GNR01-HY	2024/10/24	1750	50	D1750V2-1112	EX3DV4 - SN7590	DAE4 Sn1776	1.760	36.900	35.2	-4.61
SAR-5GNR01-HY	2024/10/17	3500	50	D3500V2-1014	EX3DV4 - SN7793	DAE4ip Sn1800	3.090	67.200	61.8	-8.04